

LPC2917/2919/01

ARM9 microcontroller with CAN and LIN

Rev. 03 — 9 December 2009

1. General description

The LPC2917/2919/01 combine an ARM968E-S CPU core with two integrated TCM blocks operating at frequencies of up to 125 MHz, CAN and LIN, 56 kB SRAM, up to 768 kB flash memory, external memory interface, two 10-bit ADCs, and multiple serial and parallel interfaces in a single chip targeted at consumer, industrial, medical, and communication markets. To optimize system power consumption, the LPC2917/2919/01 has a very flexible Clock Generation Unit (CGU) that provides dynamic clock gating and scaling.

2. Features

- ARM968E-S processor running at frequencies of up to 125 MHz maximum.
- Multi-layer AHB system bus at 125 MHz with three separate layers.
- On-chip memory:
 - Two Tightly Coupled Memories (TCM), 16 kB Instruction TCM (ITCM), 16 kB Data TCM (DTCM).
 - Two separate internal Static RAM (SRAM) instances; 32 kB SRAM and 16 kB SRAM.
 - ◆ 8 kB ETB SRAM also available for code execution and data.
 - Up to 768 kB high-speed flash-program memory.
 - ◆ 16 kB true EEPROM, byte-erasable and programmable.
- Dual-master, eight-channel GPDMA controller on the AHB multi-layer matrix which can be used with the SPI interfaces and the UARTs, as well as for memory-to-memory transfers including the TCM memories.
- External Static Memory Controller (SMC) with eight memory banks; up to 32-bit data bus; up to 24-bit address bus.
- Serial interfaces:
 - Two-channel CAN controller supporting FullCAN and extensive message filtering
 - Two LIN master controllers with full hardware support for LIN communication. The LIN interface can be configured as UART to provide two additional UART interfaces.
 - Two 550 UARTs with 16-byte Tx and Rx FIFO depths, DMA support, and RS485/EIA-485 (9 bit) support.
 - Three full-duplex Q-SPIs with four slave-select lines; 16 bits wide; 8 locations deep; Tx FIFO and Rx FIFO.
 - Two I²C-bus interfaces.



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- Other peripherals:
 - Two 10-bit ADCs, 8 channels each, with 3.3 V measurement range and conversion times as low as 2.44 μs per channel. Each channel provides a compare function to minimize interrupts.
 - Multiple trigger-start option for all ADCs: timer, PWM, other ADC, and external signal input.
 - Four 32-bit timers each containing four capture-and-compare registers linked to I/Os.
 - Four six-channel PWMs (Pulse-Width Modulators) with capture and trap functionality.
 - Two dedicated 32-bit timers to schedule and synchronize PWM and ADC.
 - Quadrature encoder interface that can monitor one external quadrature encoder.
 - ◆ 32-bit watchdog with timer change protection, running on safe clock.
- Up to 108 general-purpose I/O pins with programmable pull-up, pull-down, or bus keeper.
- Vectored Interrupt Controller (VIC) with 16 priority levels.
- Up to 19 level-sensitive external interrupt pins, including CAN and LIN wake-up features.
- Configurable clock-out pin for driving external system clocks.
- Processor wake-up from power-down via external interrupt pins; CAN or LIN activity.
- Flexible Reset Generator Unit (RGU) able to control resets of individual modules.
- Flexible Clock-Generation Unit (CGU0) able to control clock frequency of individual modules:
 - On-chip very low-power ring oscillator; fixed frequency of 0.4 MHz; always on to provide a Safe_Clock source for system monitoring.
 - On-chip crystal oscillator with a recommended operating range from 10 MHz to 25 MHz. PLL input range 10 MHz to 25 MHz.
 - On-chip PLL allows CPU operation up to a maximum CPU rate of 125 MHz.
 - Generation of up to 11 base clocks.
 - Seven fractional dividers.
- Second CGU (CGU1) with its own PLL generates a configurable clock output.
- Highly configurable system Power Management Unit (PMU):
 - clock control of individual modules.
 - ◆ allows minimization of system operating power consumption in any configuration.
- Standard ARM test and debug interface with real-time in-circuit emulator.
- Boundary-scan test supported.
- ETM/ETB debug functions with 8 kB of dedicated SRAM also accessible for application code and data storage.
- Dual power supply:
 - CPU operating voltage: 1.8 V \pm 5 %.
 - ◆ I/O operating voltage: 2.7 V to 3.6 V; inputs tolerant up to 5.5 V.
- 144-pin LQFP package.
- -40 °C to +85 °C ambient operating temperature range.

3. Ordering information

Table 1. Ordering information					
Type number Package					
	Name	Description	Version		
LPC2917FBD144/01	LQFP144	plastic low profile quad flat package; 144 leads; body $20 \times 20 \times 1.4$ mm	SOT486-1		
LPC2919FBD144/01	LQFP144	plastic low profile quad flat package; 144 leads; body 20 \times 20 \times 1.4 mm	SOT486-1		

3.1 Ordering options

Table 2. **Part options** SRAM SMC LIN 2.0 CAN Type number Flash memory Package LPC2917FBD144/01 512 kB 56 kB + 2 × 16 kB TCM 32-bit 2 LQFP144 2 LPC2919FBD144/01 768 kB 56 kB + 2 × 16 kB TCM 32-bit 2 2 LQFP144

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4. Block diagram

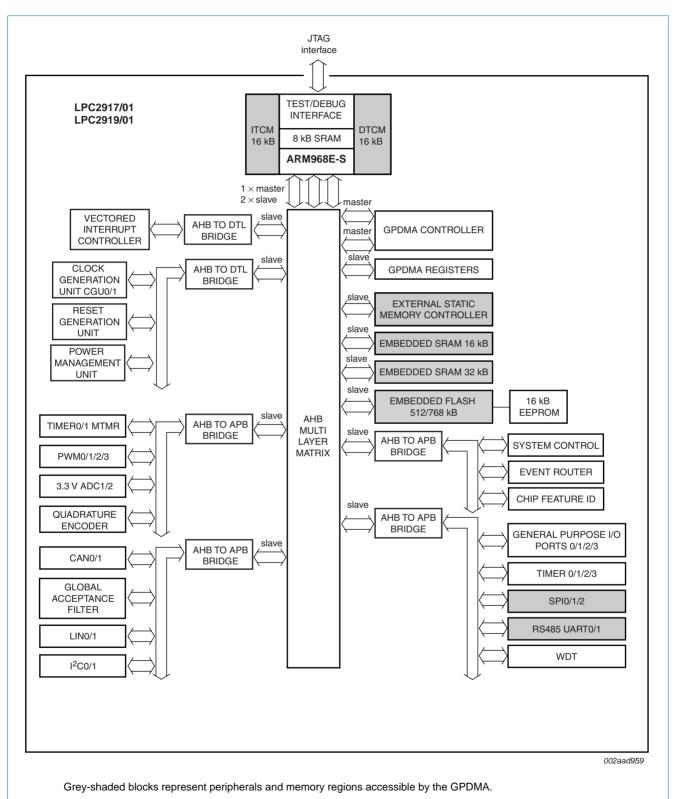


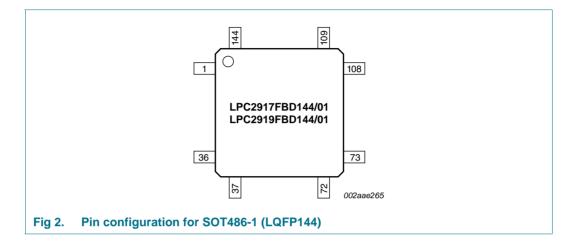
Fig 1. LPC2917/2919/01 block diagram

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Product data sheet

5. Pinning information

5.1 Pinning



5.2 Pin description

5.2.1 General description

The LPC2917/2919/01 has up to four ports: two of 32 pins each, one of 28 pins and one of 16 pins. The pin to which each function is assigned is controlled by the SFSP registers in the SCU. The functions combined on each port pin are shown in the pin description tables in this section.

5.2.2 LQFP144 pin assignment

Table 3. LQFI	Table 3. LQFP144 pin assignment						
Pin name	Pin	Description	Description				
		Default function	Function 1	Function 2	Function 3		
TDO	1 <u>[1]</u>	IEEE 1149.1 test data out	t				
P2[21]/SDI2/ PCAP2[1]/D19	2 <mark>[1]</mark>	GPIO 2, pin 21	SPI2 SDI	PWM2 CAP1	EXTBUS D19		
P0[24]/TXD1/ TXDC1/SCS2[0]	3 <mark>[1]</mark>	GPIO 0, pin 24	UART1 TXD	CAN1 TXD	SPI2 SCS0		
P0[25]/RXD1/ RXDC1/SDO2	4 <u>[1]</u>	GPIO 0, pin 25	UART1 RXD	CAN1 RXD	SPI2 SDO		
P0[26]/TXD1/ SDI2	5 <u>[1]</u>	GPIO 0, pin 26	-	UART1 TXD	SPI2 SDI		
P0[27]/RXD1/ SCK2	6 <mark>[1]</mark>	GPIO 0, pin 27	-	UART1 RXD	SPI2 SCK		
P0[28]/CAP0[0]/ MAT0[0]	7 <u>[1]</u>	GPIO 0, pin 28	-	TIMER0 CAP0	TIMER0 MAT0		
P0[29]/CAP0[1]/ MAT0[1]	8 <mark>[1]</mark>	GPIO 0, pin 29	-	TIMER0 CAP1	TIMER0 MAT1		
V _{DD(IO)}	9	3.3 V power supply for I/0	C				

Table 3. LQFP144 pin assignment

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Table 3. LQFF	P144 pin	assignmentcontinued			
Pin name	Pin	Description			
		Default function	Function 1	Function 2	Function 3
P2[22]/SCK2/ PCAP2[2]/D20	10 <mark>11</mark>	GPIO 2, pin 22	SPI2 SCK	PWM2 CAP2	EXTBUS D20
P2[23]/SCS1[0]/ PCAP3[0]/D21	11 <u>[1]</u>	GPIO 2, pin 23	SPI1 SCS0	PWM3 CAP0	EXTBUS D21
P3[6]/SCS0[3]/ PMAT1[0]/ TXDL1	12 <mark>11</mark>	GPIO 3, pin 6	SPI0 SCS3	PWM1 MAT0	LIN1/UART TXD
P3[7]/SCS2[1]/ PMAT1[1]/ RXDL1	13 <mark>[1]</mark>	GPIO 3, pin 7	SPI2 SCS1	PWM1 MAT1	LIN1/UART RXD
P0[30]/CAP0[2]/ MAT0[2]	14 <mark>11</mark>	GPIO 0, pin 30	-	TIMER0 CAP2	TIMER0 MAT2
P0[31]/CAP0[3]/ MAT0[3]	15 <mark>[1]</mark>	GPIO 0, pin 31	-	TIMER0 CAP3	TIMER0 MAT3
P2[24]/SCS1[1]/ PCAP3[1]/D22	16 <mark>11</mark>	GPIO 2, pin 24	SPI1 SCS1	PWM3 CAP1	EXTBUS D22
P2[25]/SCS1[2]/ PCAP3[2]/D23	17 <mark>11</mark>	GPIO 2, pin 25	SPI1 SCS2	PWM3 CAP2	EXTBUS D23
V _{DD(CORE)}	18	1.8 V power supply for di	gital core		
V _{SS(CORE)}	19	ground for digital core			
P1[31]/CAP0[1]/ MAT0[1]/EI5	20 <mark>[1]</mark>	GPIO 1, pin 31	TIMER0 CAP1	TIMER0 MAT1	EXTINT5
V _{SS(IO)}	21	ground for I/O			
P1[30]/CAP0[0]/ MAT0[0]/EI4	22 <mark>[1]</mark>	GPIO 1, pin 30	TIMER0 CAP0	TIMER0 MAT0	EXTINT4
P3[8]/SCS2[0]/ PMAT1[2]	23 <mark>[1]</mark>	GPIO 3, pin 8	SPI2 SCS0	PWM1 MAT2	-
P3[9]/SDO2/PM AT1[3]	24 <mark>[1]</mark>	GPIO 3, pin 9	SPI2 SDO	PWM1 MAT3	-
P1[29]/CAP1[0]/ TRAP0/ PMAT3[5]	25 <mark>[1]</mark>	GPIO 1, pin 29	TIMER1 CAP0	PWM TRAP0	PWM3 MAT5
P1[28]/CAP1[1]/ TRAP1/ PMAT3[4]	26 <mark>[1]</mark>	GPIO 1, pin 28	TIMER1 CAP1, ADC1 EXT START	PWM TRAP1	PWM3 MAT4
P2[26]/CAP0[2]/ MAT0[2]/EI6	27 <mark>[1]</mark>	GPIO 2, pin 26	TIMER0 CAP2	TIMER0 MAT2	EXTINT6
P2[27]/CAP0[3]/ MAT0[3]/EI7	28 <mark>[1]</mark>	GPIO 2, pin 27	TIMER0 CAP3	TIMER0 MAT3	EXTINT7
P1[27]/CAP1[2]/ TRAP2/ PMAT3[3]	29 <mark>[1]</mark>	GPIO 1, pin 27	TIMER1 CAP2, ADC2 EXT START	PWM TRAP2	PWM3 MAT3
P1[26]/ PMAT2[0]/ TRAP3/ PMAT3[2]	30 <mark>[1]</mark>	GPIO 1, pin 26	PWM2 MAT0	PWM TRAP3	PWM3 MAT2

Table 3. LQFP144 pin assignment ...continued

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Table 3. LQFI	P144 pin	assignment continued			
Pin name	Pin	Description			
		Default function	Function 1	Function 2	Function 3
V _{DD(IO)}	31	3.3 V power supply for I/	C		
P1[25]/ PMAT1[0]/ PMAT3[1]	32 <mark>[1]</mark>	GPIO 1, pin 25	PWM1 MAT0	-	PWM3 MAT1
P1[24]/ PMAT0[0]/ PMAT3[0]	33 <mark>[1]</mark>	GPIO 1, pin 24	PWM0 MAT0	-	PWM3 MAT0
P1[23]/ RXD0/CS5	34 <mark>[1]</mark>	GPIO 1, pin 23	UART0 RXD	-	EXTBUS CS5
P1[22]/TXD0/ CS4	35 <mark>[1]</mark>	GPIO 1, pin 22	UART0 TXD	-	EXTBUS CS4
TMS	36 <mark>11</mark>	IEEE 1149.1 test mode s	elect, pulled up internally	/	
ТСК	37 <mark>[1]</mark>	IEEE 1149.1 test clock			
P1[21]/CAP3[3]/ CAP1[3]/D7	38 <mark>[1]</mark>	GPIO 1, pin 21	TIMER3 CAP3	TIMER1 CAP3, MSCSS PAUSE	EXTBUS D7
P1[20]/CAP3[2]/ SCS0[1]/D6	39 <mark>[1]</mark>	GPIO 1, pin 20	TIMER3 CAP2	SPI0 SCS1	EXTBUS D6
P1[19]/CAP3[1]/ SCS0[2]/D5	40 <mark>[1]</mark>	GPIO 1, pin 19	TIMER3 CAP1	SPI0 SCS2	EXTBUS D5
P1[18]/CAP3[0]/ SDO0/D4	41 <mark>11</mark>	GPIO 1, pin 18	TIMER3 CAP0	SPI0 SDO	EXTBUS D4
P1[17]/CAP2[3]/ SDI0/D3	42 <mark>[1]</mark>	GPIO 1, pin 17	TIMER2 CAP3	SPI0 SDI	EXTBUS D3
V _{SS(IO)}	43	ground for I/O			
P1[16]/CAP2[2]/ SCK0/D2	44 <u>[1]</u>	GPIO 1, pin 16	TIMER2 CAP2	SPI0 SCK	EXTBUS D2
P2[0]/MAT2[0]/ TRAP3/D8	45 <mark>[1]</mark>	GPIO 2, pin 0	TIMER2 MAT0	PWM TRAP3	EXTBUS D8
P2[1]/MAT2[1]/ TRAP2/D9	46 <mark>[1]</mark>	GPIO 2, pin 1	TIMER2 MAT1	PWM TRAP2	EXTBUS D9
P3[10]/SDI2/ PMAT1[4]	47 <mark>[1]</mark>	GPIO 3, pin 10	SPI2 SDI	PWM1 MAT4	-
P3[11]/SCK2/ PMAT1[5]	48 <mark>[1]</mark>	GPIO 3, pin 11	SPI2 SCK	PWM1 MAT5	-
P1[15]/CAP2[1]/ SCS0[0]/D1	49 <mark>[1]</mark>	GPIO 1, pin 15	TIMER2 CAP1	SPI0 SCS0	EXTBUS D1
P1[14]/CAP2[0]/ SCS0[3]/D0	50 <mark>[1]</mark>	GPIO 1, pin 14	TIMER2 CAP0	SPI0 SCS3	EXTBUS D0
P1[<u>13]/</u> SCL1/ EI3/WE	51 <mark>[1]</mark>	GPIO 1, pin 13	EXTINT3	I2C1 SCL	EXTBUS WE
P1[<u>12]</u> /SDA1/ EI2/OE	52 <mark>11</mark>	GPIO 1, pin 12	EXTINT2	I2C1 SDA	EXTBUS OE
V _{DD(IO)}	53	3.3 V power supply for I/0	C		
P2[2]/MAT2[2]/ TRAP1/D10	54 <mark>[1]</mark>	GPIO 2, pin 2	TIMER2 MAT2	PWM TRAP1	EXTBUS D10

Table 3. LQFP144 pin assignment ...continued

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Table 3. LQFF	P144 pir	n assignmentcontinued			
Pin name	Pin	Description			
		Default function	Function 1	Function 2	Function 3
P2[3]/MAT2[3]/ TRAP0/D11	55 <mark>[1]</mark>	GPIO 2, pin 3	TIMER2 MAT3	PWM TRAP0	EXTBUS D11
P1[11] <u>/SC</u> K1/ SCL0/CS3	56 <mark>[1]</mark>	GPIO 1, pin 11	SPI1 SCK	I2C0 SCL	EXTBUS CS3
P1[10] <u>/SDI</u> 1/ SDA0/CS2	57 <mark>[1]</mark>	GPIO 1, pin 10	SPI1 SDI	I2C0 SDA	EXTBUS CS2
P3[12]/SCS1[0]/ EI4	58 <mark>[1]</mark>	GPIO 3, pin 12	SPI1 SCS0	EXTINT4	-
V _{SS(CORE)}	59	ground for digital core			
DD(CORE)	60	1.8 V power supply for c	ligital core		
P3[13]/SDO1/ EI5/IDX0	61 <mark>[1]</mark>	GPIO 3, pin 13	SPI1 SDO	EXTINT5	QEI0 IDX
P2[4]/MAT1[0]/ EI0/D12	62 <mark>[1]</mark>	GPIO 2, pin 4	TIMER1 MAT0	EXTINT0	EXTBUS D12
P2[5]/MAT1[1]/ EI1/D13	63 <mark>[1]</mark>	GPIO 2, pin 5	TIMER1 MAT1	EXTINT1	EXTBUS D13
P1[9]/S <u>DO1/</u> RXDL1/CS1	64 <u>[1]</u>	GPIO 1, pin 9	SPI1 SDO	LIN1/UART RXD	EXTBUS CS1
/ _{SS(IO)}	65	ground for I/O			
P1[8]/S <u>CS1[</u> 0]/ FXDL1/ <u>CS0</u>	66 <mark>[1]</mark>	GPIO 1, pin 8	SPI1 SCS0	LIN1/UART TXD	EXTBUS CS0
P1[7]/SCS1[3]/ RXD1/A7	67 <u>[1]</u>	GPIO 1, pin 7	SPI1 SCS3	UART1 RXD	EXTBUS A7
P1[6]/SCS1[2]/ TXD1/A6	68 <mark>[1]</mark>	GPIO 1, pin 6	SPI1 SCS2	UART1 TXD	EXTBUS A6
P2[6]/MAT1[2]/ El2/D14	69 <mark>[1]</mark>	GPIO 2, pin 6	TIMER1 MAT2	EXTINT2	EXTBUS D14
P1[5]/SCS1[1]/ PMAT3[5]/A5	70 <u>[1]</u>	GPIO 1, pin 5	SPI1 SCS1	PWM3 MAT5	EXTBUS A5
P1[4]/SCS2[2]/ PMAT3[4]/A4	71 <mark>11</mark>	GPIO 1, pin 4	SPI2 SCS2	PWM3 MAT4	EXTBUS A4
TRST	72 <mark>[1]</mark>	IEEE 1149.1 test reset N	NOT; active LOW; pulled	l up internally	
RST	73 <mark>[1]</mark>	asynchronous device re	set; active LOW; pulled	up internally	
/ _{SS(OSC)}	74	ground for oscillator			
KOUT_OSC	75 <mark>2</mark>	crystal out for oscillator			
(IN_OSC	76 <mark>2</mark>	crystal in for oscillator			
/ _{DD(OSC)}	77	1.8 V supply for oscillate	or		
/ _{SS(PLL)}	78	ground for PLL			
P2[7]/MAT1[3]/ EI3/D15	79 <mark>[1]</mark>	GPIO 2, pin 7	TIMER1 MAT3	EXTINT3	EXTBUS D15
P3[14]/SDI1/ EI6/TXDC0	80 <mark>[1]</mark>	GPIO 3, pin 14	SPI1 SDI	EXTINT6	CAN0 TXD
P3[15]/SCK1/ EI7/RXDC0	81 <mark>[1]</mark>	GPIO 3, pin 15	SPI1 SCK	EXTINT7	CAN0 RXD

Table 3. LQFP144 pin assignment ...continued

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Table 3. LQFF	² 144 pin	assignmentcontinued			
Pin name	Pin	Description			
		Default function	Function 1	Function 2	Function 3
V _{DD(IO)}	82	3.3 V power supply for I/	0		
P2[8]/ CLK_OUT/ PMAT0[0]/ SCS0[2]	83 <mark>[1]</mark>	GPIO 2, pin 8	CLK_OUT	PWM0 MAT0	SPI0 SCS2
P2[9]/PMAT0[1]/ SCS0[1]	84 <mark>[1]</mark>	GPIO 2, pin 9	•	PWM0 MAT1	SPI0 SCS1
P1[3]/SCS2[1]/ PMAT3[3]/A3	85 <mark>[1]</mark>	GPIO 1, pin 3	SPI2 SCS1	PWM3 MAT3	EXTBUS A3
P1[2]/SCS2[3]/ PMAT3[2]/A2	86 <mark>[1]</mark>	GPIO 1, pin 2	SPI2 SCS3	PWM3 MAT2	EXTBUS A2
P1[1]/El1/ PMAT3[1]/A1	87 <mark>11</mark>	GPIO 1, pin 1	EXTINT1	PWM3 MAT1	EXTBUS A1
V _{SS(CORE)}	88	ground for digital core			
V _{DD(CORE)}	89	1.8 V power supply for di	gital core		
P1[0]/EI0/ PMAT3[0]/A0	90 <mark>[1]</mark>	GPIO 1, pin 0	EXTINT0	PWM3 MAT0	EXTBUS A0
P2[10]/ PMAT0[2]/ SCS0[0]	91 <mark>11</mark>	GPIO 2, pin 10	-	PWM0 MAT2	SPI0 SCS0
P2[11]/ PMAT0[3]/SCK0	92 <mark>[1]</mark>	GPIO 2, pin 11	-	PWM0 MAT3	SPI0 SCK
P0[0]/PHB0/ TXDC0/D24	93 <mark>[1]</mark>	GPIO 0, pin 0	QEI0 PHB	CAN0 TXD	EXTBUS D24
V _{SS(IO)}	94	ground for I/O			
P0[1]/PHA0/ RXDC0/D25	95 <mark>[1]</mark>	GPIO 0, pin 1	QEI 0 PHA	CAN0 RXD	EXTBUS D25
P0[2]/ CLK_OUT/ PMAT0[0]/D26	96 <mark>[1]</mark>	GPIO 0, pin 2	CLK_OUT	PWM0 MAT0	EXTBUS D26
P0[3]/PMAT0[1]/ D27	97 <mark>[1]</mark>	GPIO 0, pin 3	-	PWM0 MAT1	EXTBUS D27
P3[0]/PMAT2[0]/ CS6	98 <mark>[1]</mark>	GPIO 3, pin 0	-	PWM2 MAT0	EXTBUS CS6
P3[1]/PMAT2[1]/ CS7	99 <mark>[1]</mark>	GPIO 3, pin 1	-	PWM2 MAT1	EXTBUS CS7
P2[12]/ PMAT0[4]/SDI0	100 <mark>[1]</mark>	GPIO 2, pin 12	-	PWM0 MAT4	SPI0 SDI
P2[13]/ PMAT0[5]/ SDO0	101[1]	GPIO 2, pin 13	-	PWM0 MAT5	SPI0 SDO
P0[4]/PMAT0[2]/ D28	102 <mark>[1]</mark>	GPIO 0, pin 4	-	PWM0 MAT2	EXTBUS D28
P0[5]/PMAT0[3]/ D29	103 <mark>[1]</mark>	GPIO 0, pin 5	-	PWM0 MAT3	EXTBUS D29
V _{DD(IO)}	104	3.3 V power supply for I/	C		

Table 3. LQFP144 pin assignment ...continued

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Table 3. LQFF	P144 pin	assignmentcontinued			
Pin name	Pin	Description			
		Default function	Function 1	Function 2	Function 3
P0[6]/ PMAT0[4]/D30	105 <mark>11</mark>	GPIO 0, pin 6	-	PWM0 MAT4	EXTBUS D30
P0[7]/ PMAT0[5]/D31	106 <mark>[1]</mark>	GPIO 0, pin 7	-	PWM0 MAT5	EXTBUS D31
V _{DDA(ADC3V3)}	107	3.3 V power supply for A	DC		
JTAGSEL	108 <mark>[1]</mark>	TAP controller select inp boundary scan; pulled up		e ARM debug mode; HI	GH-level selects
n.c.	109	not connected to a functi	on, must be tied to 3.3 V	power supply for ADC	V _{DDA(ADC3V3)} .
VREFP	110 <mark>2</mark>	HIGH reference for ADC			
VREFN	111 <mark>2</mark>	LOW reference for ADC			
P0[8]/IN1[0]/TX DL0/A20	112 <mark>3</mark>	GPIO 0, pin 8	ADC1 IN0	LIN0/UART TXD	EXTBUS A20
P0[9]/IN1[1]/ RXDL0/A21	113 <mark>[3]</mark>	GPIO 0, pin 9	ADC1 IN1	LIN0/UART RXD	EXTBUS A21
P0[10]/IN1[2]/ PMAT1[0]/A8	114 <mark>3)</mark>	GPIO 0, pin 10	ADC1 IN2	PWM1 MAT0	EXTBUS A8
P0[11]/IN1[3]/ PMAT1[1]/A9	115 <mark>3</mark>	GPIO 0, pin 11	ADC1 IN3	PWM1 MAT1	EXTBUS A9
P2[14]/SDA1/ PCAP0[0]/BLS0	116 <mark>11</mark>	GPIO 2, pin 14	I2C1 SDA	PWM0 CAP0	EXTBUS BLS0
P2[15]/SCL1/ PCAP0[1]/BLS1	117 <mark>11</mark>	GPIO 2, pin 15	I2C1 SCL	PWM0 CAP1	EXTBUS BLS1
P3[2]/MAT3[0]/ PMAT2[2]	118 <mark>[1]</mark>	GPIO 3, pin 2	TIMER3 MAT0	PWM2 MAT2	-
V _{SS(IO)}	119	ground for I/O			
P3[3]/MAT3[1]/ PMAT2[3]	120 <mark>[1]</mark>	GPIO 3, pin 3	TIMER3 MAT1	PWM2 MAT3	-
P0[12]/IN1[4]/ PMAT1[2]/A10	121 <mark>3</mark>	GPIO 0, pin 12	ADC1 IN4	PWM1 MAT2	EXTBUS A10
P0[13]/IN1[5]/ PMAT1[3]/A11	122 <mark>3]</mark>	GPIO 0, pin 13	ADC1 IN5	PWM1 MAT3	EXTBUS A11
P0[14]/IN1[6]/ PMAT1[4]/A12	123 <mark>3</mark>	GPIO 0, pin 14	ADC1 IN6	PWM1 MAT4	EXTBUS A12
P0[15]/IN1[7]/ PMAT1[5]/A13	124 <mark>3]</mark>	GPIO 0, pin 15	ADC1 IN7	PWM1 MAT5	EXTBUS A13
P0[16]IN2[0]/ TXD0/A22	125 <mark>[3]</mark>	GPIO 0, pin 16	ADC2 IN0	UART0 TXD	EXTBUS A22
P0[17]/IN2[1]/ RXD0/A23	126 <mark>[3]</mark>	GPIO 0, pin 17	ADC2 IN1	UART0 RXD	EXTBUS A23
V _{DD(CORE)}	127	1.8 V power supply for di	gital core		
V _{SS(CORE)}	128	ground for digital core			
P2[16]/TXD1/ PCAP0[2]/BLS2	129 <mark>[1]</mark>	GPIO 2, pin 16	UART1 TXD	PWM0 CAP2	EXTBUS BLS2
P2[17]/RX <u>D1/</u> PCAP1[0]/BLS3	130 <mark>[1]</mark>	GPIO 2, pin 17	UART1 RXD	PWM1 CAP0	EXTBUS BLS3

Table 3. LQFP144 pin assignment ...continued

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	Table 3. LQFP144 pin assignmentcontinued					
Pin name	Pin	Description				
		Default function	Function 1	Function 2	Function 3	
V _{DD(IO)}	131	3.3 V power supply for I/0	Ó			
P0[18]/IN2[2]/ PMAT2[0]/A14	132 <mark>3</mark>	GPIO 0, pin 18	ADC2 IN2	PWM2 MAT0	EXTBUS A14	
P0[19]/IN2[3]/ PMAT2[1]/A15	133 <mark>3]</mark>	GPIO 0, pin 19	ADC2 IN3	PWM2 MAT1	EXTBUS A15	
P3[4]/MAT3[2]/ PMAT2[4]/ TXDC1	134 <mark>11</mark>	GPIO 3, pin 4	TIMER3 MAT2	PWM2 MAT4	CAN1 TXD	
P3[5]/MAT3[3]/ PMAT2[5]/ RXDC1	135 <mark>[1]</mark>	GPIO 3, pin 5	TIMER3 MAT3	PWM2 MAT5	CAN1 RXD	
P2[18]/SCS2[1]/ PCAP1[1]/D16	136 <mark>[1]</mark>	GPIO 2, pin 18	SPI2 SCS1	PWM1 CAP1	EXTBUS D16	
P2[19]/SCS2[0]/ PCAP1[2]/D17	137 <mark>[1]</mark>	GPIO 2, pin 19	SPI2 SCS0	PWM1 CAP2	EXTBUS D17	
P0[20]/IN2[4]/ PMAT2[2]/A16	138 <mark>3]</mark>	GPIO 0, pin 20	ADC2 IN4	PWM2 MAT2	EXTBUS A16	
P0[21]/IN2[5]/ PMAT2[3]/A17	139 <mark>3]</mark>	GPIO 0, pin 21	ADC2 IN5	PWM2 MAT3	EXTBUS A17	
P0[22]/IN2[6]/ PMAT2[4]/A18	140 <mark>[3]</mark>	GPIO 0, pin 22	ADC2 IN6	PWM2 MAT4	EXTBUS A18	
V _{SS(IO)}	141	ground for I/O				
P0[23]/IN2[7]/ PMAT2[5]/A19	142 <mark>3]</mark>	GPIO 0, pin 23	ADC2 IN7	PWM2 MAT5	EXTBUS A19	
P2[20]/ PCAP2[0]/D18	143 <mark>[1]</mark>	GPIO 2, pin 20	SPI2 SDO	PWM2 CAP0	EXTBUS D18	
TDI	144 <mark>[1]</mark>	IEEE 1149.1 data in, pull	ed up internally			

Table 3. LQFP144 pin assignment ... continued

[1] Bidirectional pad; analog port; plain input; 3-state output; slew rate control; 5V tolerant; TTL with hysteresis; programmable pull-up / pull-down / repeater.

[2] Analog pad; analog I/O

[3] Analog pad.

6. Functional description

6.1 Architectural overview

The LPC2917/2919/01 consists of:

- An ARM968E-S processor with real-time emulation support
- An AMBA multi-layer Advanced High-performance Bus (AHB) for interfacing to the on-chip memory controllers
- Two DTL buses (an universal NXP interface) for interfacing to the interrupt controller and the Power, Clock and Reset Control cluster (also called subsystem).

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- Three ARM Peripheral Buses (APB a compatible superset of ARM's AMBA advanced peripheral bus) for connection to on-chip peripherals clustered in subsystems.
- One ARM Peripheral Bus for event router and system control.

The LPC2917/2919/01 configures the ARM968E-S processor in little-endian byte order. All peripherals run at their own clock frequency to optimize the total system power consumption. The AHB2APB bridge used in the subsystems contains a write-ahead buffer one transaction deep. This implies that when the ARM968E-S issues a buffered write action to a register located on the APB side of the bridge, it continues even though the actual write may not yet have taken place. Completion of a second write to the same subsystem will not be executed until the first write is finished.

6.2 ARM968E-S processor

The ARM968E-S is a general purpose 32-bit RISC processor, which offers high performance and very low power consumption. The ARM architecture is based on Reduced Instruction Set Computer (RISC) principles, and the instruction set and related decode mechanism are much simpler than those of microprogrammed Complex Instruction Set Computers (CISC). This simplicity results in a high instruction throughput and impressive real-time interrupt response from a small and cost-effective controller core.

Amongst the most compelling features of the ARM968E-S are:

- Separate directly connected instruction and data Tightly Coupled Memory (TCM) interfaces
- Write buffers for the AHB and TCM buses
- Enhanced 16 × 32 multiplier capable of single-cycle MAC operations and 16-bit fixedpoint DSP instructions to accelerate signal-processing algorithms and applications.

Pipeline techniques are employed so that all parts of the processing and memory systems can operate continuously. The ARM968E-S is based on the ARMv5TE five-stage pipeline architecture. Typically, in a three-stage pipeline architecture, while one instruction is being executed its successor is being decoded and a third instruction is being fetched from memory. In the five-stage pipeline additional stages are added for memory access and write-back cycles.

The ARM968E-S processor also employs a unique architectural strategy known as THUMB, which makes it ideally suited to high-volume applications with memory restrictions or to applications where code density is an issue.

The key idea behind THUMB is that of a super-reduced instruction set. Essentially, the ARM968E-S processor has two instruction sets:

- Standard 32-bit ARMv5TE set
- 16-bit THUMB set

The THUMB set's 16-bit instruction length allows it to approach twice the density of standard ARM code while retaining most of the ARM's performance advantage over a traditional 16-bit controller using 16-bit registers. This is possible because THUMB code operates on the same 32-bit register set as ARM code.

THUMB code can provide up to 65 % of the code size of ARM, and 160 % of the performance of an equivalent ARM controller connected to a 16-bit memory system.

The ARM968E-S processor is described in detail in the ARM968E-S data sheet Ref. 2.

6.3 On-chip flash memory system

The LPC2917/2919/01 includes a 512 kB or 768 kB flash memory system. This memory can be used for both code and data storage. Programming of the flash memory can be accomplished via the flash memory controller or JTAG.

The flash controller also supports a 16 kB, byte-accessible on-chip EEPROM integrated on the LPC2917/2919/01.

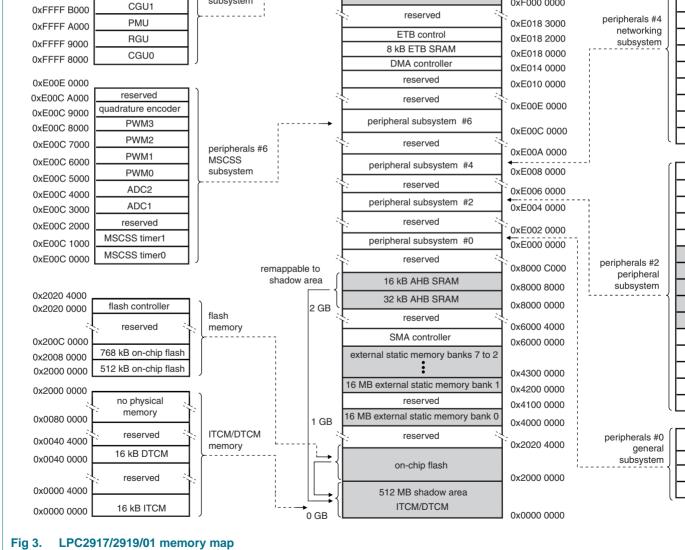
6.4 On-chip static RAM

In addition to the two 16 kB TCMs the LPC2917/2919/01 includes two static RAM memories: one of 32 kB and one of 16 kB. Both may be used for code and/or data storage.

In addition, 8 kB SRAM for the ETB can be used as static memory for code and data storage. However, DMA access to this memory region is not supported.







4 GB

LPC2917/2919/01

PCR/VIC control

reserved

DMA interface to TCM

0xFFFF FFFF

0xFFFF 8000

0xF080 0000

0xF000 0000

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0xFFFF FFFF

0xFFFF F000

0xFFFF C000

VIC

reserved

PCR/VIC

subsystem

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6.6 Reset, debug, test, and power description

6.6.1 Reset and power-up behavior

The LPC2917/2919/01 contains external reset input and internal power-up reset circuits. This ensures that a reset is extended internally until the oscillators and flash have reached a stable state. See <u>Section 8</u> for trip levels of the internal power-up reset circuit¹. See <u>Section 9</u> for characteristics of the several start-up and initialization times. <u>Table 4</u> shows the reset pin.

Table 4.	Reset pin	
Symbol	Direction	Description
RST	IN	external reset input, active LOW; pulled up internally

At activation of the RST pin the JTAGSEL pin is sensed as logic LOW. If this is the case the LPC2917/2919/01 is assumed to be connected to debug hardware, and internal circuits re-program the source for the BASE_SYS_CLK to be the crystal oscillator instead of the Low-Power Ring Oscillator (LP_OSC). This is required because the clock rate when running at LP_OSC speed is too low for the external debugging environment.

6.6.2 Reset strategy

The LPC2917/2919/01 contains a central module, the Reset Generator Unit (RGU) in the Power, Clock and Reset Subsystem (PCRSS), which controls all internal reset signals towards the peripheral modules. The RGU provides individual reset control as well as the monitoring functions needed for tracing a reset back to source.

6.6.3 IEEE 1149.1 interface pins (JTAG boundary-scan test)

The LPC2917/2919/01 contains boundary-scan test logic according to IEEE 1149.1, also referred to in this document as Joint Test Action Group (JTAG). The boundary-scan test pins can be used to connect a debugger probe for the embedded ARM processor. Pin JTAGSEL selects between boundary-scan mode and debug mode. <u>Table 5</u> shows the boundary- scan test pins.

Table 5. IEEE 1149.1 boundary-scan test and debug interface

Symbol	Description
JTAGSEL	TAP controller select input. LOW level selects ARM debug mode and HIGH level selects boundary scan and flash programming; pulled up internally
TRST	test reset input; pulled up internally (active LOW)
TMS	test mode select input; pulled up internally
TDI	test data input, pulled up internally
TDO	test data output
ТСК	test clock input

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^{1.} Only for 1.8 V power sources

6.6.3.1 ETM/ETB

The ETM provides real-time trace capability for deeply embedded processor cores. It outputs information about processor execution to a trace buffer. A software debugger allows configuration of the ETM using a JTAG interface and displays the trace information that has been captured in a format that a user can easily understand. The ETB stores trace data produced by the ETM.

The ETM/ETB module has the following features:

- Closely tracks the instructions that the ARM core is executing.
- On-chip trace data storage (ETB).
- All registers are programmed through JTAG interface.
- Does not consume power when trace is not being used.
- THUMB/Java instruction set support.

6.6.4 Power supply pins

Table 6 shows the power supply pins.

Table 6.	Power supply pins
Symbol	Description
V _{DD(CORE)}	digital core supply 1.8 V
V _{SS(CORE)}	digital core ground (digital core, ADC1/2)
V _{DD(IO)}	I/O pins supply 3.3 V
V _{SS(IO)}	I/O pins ground
V _{DD(OSC)}	oscillator and PLL supply
V _{SS(OSC)}	oscillator ground
V _{DDA(ADC3}	V3) ADC1 and ADC2 3.3 V supply
V _{SS(PLL)}	PLL ground

6.7 Clocking strategy

6.7.1 Clock architecture

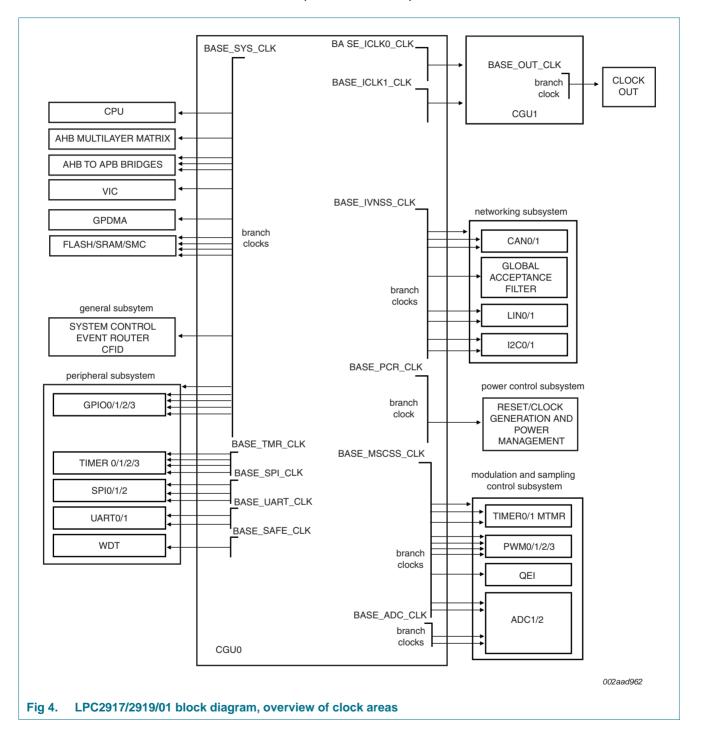
The LPC2917/2919/01 contains several different internal clock areas. Peripherals like Timers, SPI, UART, CAN and LIN have their own individual clock sources called base clocks. All base clocks are generated by the Clock Generator Unit (CGU0). They may be unrelated in frequency and phase and can have different clock sources within the CGU.

The system clock for the CPU and AHB Bus infrastructure has its own base clock. This means most peripherals are clocked independently from the system clock. See <u>Figure 4</u> for an overview of the clock areas within the device.

Within each clock area there may be multiple branch clocks, which offers very flexible control for power-management purposes. All branch clocks are outputs of the Power Management Unit (PMU) and can be controlled independently. Branch clocks derived from the same base clock are synchronous in frequency and phase. See <u>Section 6.15</u> for more details of clock and power control within the device.

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Two of the base clocks generated by the CGU0 are used as input into a second, dedicated CGU (CGU1). The CGU1 uses its own PLL and fractional divider to generate the base clock for an independent clock output.



6.7.2 Base clock and branch clock relationship

Table 7 and Table 8 contain an overview of all the base blocks in the LPC2917/2919/01 and their derived branch clocks. In relevant cases more detailed information can be found in the specific subsystem description. Some branch clocks have special protection since they clock vital system parts of the device and should (for example) not be switched off. See Section 6.15.5 for more details of how to control the individual branch clocks.

Base clock	Branch clock name	Parts of the device clocked by this branch clock	Remark
BASE_SAFE_CLK	CLK_SAFE	watchdog timer	<u>[1]</u>
BASE_SYS_CLK	CLK_SYS_CPU	ARM968E-S and TCMs	
	CLK_SYS_SYS	AHB bus infrastructure	
	CLK_SYS_PCRSS	AHB side of bridge in PCRSS	
	CLK_SYS_FMC	Flash-Memory Controller	
	CLK_SYS_RAM0	Embedded SRAM Controller 0 (32 kB)	
	CLK_SYS_RAM1	Embedded SRAM Controller 1 (16 kB)	
	CLK_SYS_SMC	External Static-Memory Controller	
	CLK_SYS_GESS	General Subsystem	
	CLK_SYS_VIC	Vectored Interrupt Controller	
	CLK_SYS_PESS	Peripheral Subsystem	[2] [4]
	CLK_SYS_GPIO0	GPIO bank 0	
	CLK_SYS_GPIO1	GPIO bank 1	
	CLK_SYS_GPIO2	GPIO bank 2	
	CLK_SYS_GPIO3	GPIO bank 3	
	CLK_SYS_IVNSS_A	AHB side of bridge of IVNSS	
	CLK_SYS_MSCSS_A	AHB side of bridge of MSCSS	
	CLK_SYS_DMA	GPDMA	
BASE_PCR_CLK	CLK_PCR_SLOW	PCRSS, CGU, RGU and PMU logic clock	<u>[1]</u> , <u>[3]</u>
BASE_IVNSS_CLK	CLK_IVNSS_APB	APB side of the IVNSS	
	CLK_IVNSS_CANCA	CAN controller Acceptance Filter	
	CLK_IVNSS_CANC0	CAN channel 0	
	CLK_IVNSS_CANC1	CAN channel 1	
	CLK_IVNSS_I2C0	I2C0	
	CLK_IVNSS_I2C1	I2C1	
	CLK_IVNSS_LIN0	LIN channel 0	
	CLK_IVNSS_LIN1	LIN channel 1	

 Table 7.
 CGU0 generated base clock and branch clock overview

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Base clock	Branch clock name	Parts of the device clocked by this branch clock	Remark
BASE_MSCSS_CLK	CLK_MSCSS_APB	APB side of the MSCSS	
	CLK_MSCSS_MTMR0	Timer 0 in the MSCSS	
	CLK_MSCSS_MTMR1	Timer 1 in the MSCSS	
	CLK_MSCSS_PWM0	PWM 0	
	CLK_MSCSS_PWM1	PWM 1	
	CLK_MSCSS_PWM2	PWM 2	
	CLK_MSCSS_PWM3	PWM 3	
	CLK_MSCSS_ADC1_APB	APB side of ADC 1	
	CLK_MSCSS_ADC2_APB	APB side of ADC 2	
	CLK_MSCSS_QEI	Quadrature encoder	
BASE_UART_CLK	CLK_UART0	UART 0 interface clock	
	CLK_UART1	UART 1 interface clock	
BASE_ICLK0_CLK	-	CGU1 input clock	
BASE_SPI_CLK	CLK_SPI0	SPI 0 interface clock	
	CLK_SPI1	SPI 1 interface clock	
	CLK_SPI2	SPI 2 interface clock	
BASE_TMR_CLK	CLK_TMR0	Timer 0 clock for counter part	
	CLK_TMR1	Timer 1 clock for counter part	
	CLK_TMR2	Timer 2 clock for counter part	
	CLK_TMR3	Timer 3 clock for counter part	
BASE_ADC_CLK	CLK_ADC1	Control of ADC 1, capture sample result	
	CLK_ADC2	Control of ADC 2, capture sample result	
reserved	-	-	
BASE_ICLK1_CLK		CGU1 input clock	

Table 7. CGU0 generated base clock and branch clock overview ... continued

[1] This clock is always on (cannot be switched off for system safety reasons)

[2] In the peripheral subsystem parts of the Timers, watchdog timer, SPI and UART have their own clock source. See <u>Section 6.12</u> for details.

[3] In the Power Clock and Reset Control subsystem parts of the CGU, RGU, and PMU have their own clock source. See <u>Section 6.15</u> for details.

[4] The clock should remain activated when system wake-up on timer or UART is required.

Table 8. CGU1 base clock and branch clock overview

Base clock	Branch clock name	Parts of the device clocked by this branch clock
BASE_OUT_CLK	CLK_OUT_CLK	clockout pin

6.8 Flash memory controller

The flash memory has a 128-bit wide data interface and the flash controller offers two 128-bit buffer lines to improve system performance. The flash has to be programmed initially via JTAG. In-system programming must be supported by the bootloader. In-application programming is possible. Flash memory contents can be protected by disabling JTAG access. Suspension of burning or erasing is not supported.

The Flash Memory Controller (FMC) interfaces to the embedded flash memory for two tasks:

- Memory data transfer
- Memory configuration via triggering, programming, and erasing

The key features are:

- Programming by CPU via AHB
- Programming by external programmer via JTAG
- JTAG access protection
- · Burn-finished and erase-finished interrupt

6.8.1 Functional description

After reset, flash initialization is started, which takes t_{init} time (see <u>Section 9</u>). During this initialization, flash access is not possible and AHB transfers to flash are stalled, blocking the AHB bus.

During flash initialization, the index sector is read to identify the status of the JTAG access protection and sector security. If JTAG access protection is active, the flash is not accessible via JTAG. In this case, ARM debug facilities are disabled and flash-memory contents cannot be read. If sector security is active, only the unsecured sections can be read.

Flash can be read synchronously or asynchronously to the system clock. In synchronous operation, the flash goes into standby after returning the read data. Started reads cannot be stopped, and speculative reading and dual buffering are therefore not supported.

With asynchronous reading, transfer of the address to the flash and of read data from the flash is done asynchronously, giving the fastest possible response time. Started reads can be stopped, so speculative reading and dual buffering are supported.

Buffering is offered because the flash has a 128-bit wide data interface while the AHB interface has only 32 bits. With buffering a buffer line holds the complete 128-bit flash word, from which four words can be read. Without buffering every AHB data port read starts a flash read. A flash read is a slow process compared to the minimum AHB cycle time, so with buffering the average read time is reduced. This can improve system performance.

With single buffering, the most recently read flash word remains available until the next flash read. When an AHB data-port read transfer requires data from the same flash word as the previous read transfer, no new flash read is done and the read data is given without wait cycles.

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When an AHB data port read transfer requires data from a different flash word to that involved in the previous read transfer, a new flash read is done and wait states are given until the new read data is available.

With dual buffering, a secondary buffer line is used, the output of the flash being considered as the primary buffer. On a primary buffer, hit data can be copied to the secondary buffer line, which allows the flash to start a speculative read of the next flash word.

Both buffer lines are invalidated after:

- Initialization
- Configuration-register access
- · Data-latch reading
- Index-sector reading

The modes of operation are listed in <u>Table 9</u>.

Table 9.Flash read modes

Synchronous timing	
No buffer line	for single (non-linear) reads; one flash-word read per word read
Single buffer line	default mode of operation; most recently read flash word is kept unti another flash word is required
Asynchronous timing	
No buffer line	one flash-word read per word read
Single buffer line	most recently read flash word is kept until another flash word is required
Dual buffer line, single speculative	on a buffer miss a flash read is done, followed by at most one speculative read; optimized for execution of code with small loops (less than eight words) from flash
Dual buffer line, always speculative	most recently used flash word is copied into second buffer line; next flash-word read is started; highest performance for linear reads

6.8.2 Pin description

The flash memory controller has no external pins. However, the flash can be programmed via the JTAG pins, see <u>Section 6.6.3</u>.

6.8.3 Clock description

The flash memory controller is clocked by CLK_SYS_FMC, see Section 6.7.2.

6.8.4 Flash layout

The ARM processor can program the flash for ISP (In-System Programming) and IAP (In-Application Programming). Note that the flash always has to be programmed by 'flash words' of 128 bits (four 32-bit AHB bus words, hence 16 bytes).

The flash memory is organized into eight 'small' sectors of 8 kB each and up to 11 'large' sectors of 64 kB each. The number of large sectors depends on the device type. A sector must be erased before data can be written to it. The flash memory also has sector-wise protection. Writing occurs per page which consists of 4096 bits (32 flash words). A small sector contains 16 pages; a large sector contains 128 pages.

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Table 10. Flash sector overview				
Sector number	Sector size (kB)	Sector base address		
11	8	0x2000 0000		
12	8	0x2000 2000		
13	8	0x2000 4000		
14	8	0x2000 6000		
15	8	0x2000 8000		
16	8	0x2000 A000		
17	8	0x2000 C000		
18	8	0x2000 E000		
0	64	0x2001 0000		
1	64	0x2002 0000		
2	64	0x2003 0000		
3	64	0x2004 0000		
4	64	0x2005 0000		
5	64	0x2006 0000		
6	64	0x2007 0000		
7 <u>[1]</u>	64	0x2008 0000		
8 <u>[1]</u>	64	0x2009 0000		
9 <u>[1]</u>	64	0x200A 0000		
10 <u>^[1]</u>	64	0x200B 0000		

Table 10 gives an overview of the flash-sector base addresses.

[1] Availability of sector 15 to sector 18 depends on device type, see Section 3 "Ordering information".

The index sector is a special sector in which the JTAG access protection and sector security are located. The address space becomes visible by setting the FS_ISS bit and overlaps the regular flash sector's address space.

Note that the index sector cannot be erased, and that access to it has to be performed via code outside the flash.

6.8.5 Flash bridge wait-states

To eliminate the delay associated with synchronizing flash-read data, a predefined number of wait-states must be programmed. These depend on flash-memory response time and system clock period. The minimum wait-states value can be calculated with the following formulas:

Synchronous reading:

$$WST > \frac{t_{acc(clk)}}{t_{t_{tclk(sys)}}} - 1$$

Asynchronous reading:

$$WST > \frac{t_{acc(addr)}}{t_{tclk(sys)}} - 1$$

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Product data sheet

(1)

(2)

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Remark: If the programmed number of wait-states is more than three, flash-data reading cannot be performed at full speed (i.e. with zero wait-states at the AHB bus) if speculative reading is active.

6.8.6 EEPROM

EEPROM is a non-volatile memory mostly used for storing relatively small amounts of data, for example for storing settings. It contains one 16 kB memory block and is byte-programmable and byte-erasable.

The EEPROM can be accessed only through the flash controller.

6.9 External static memory controller

The LPC2917/2919/01 contains an external Static Memory Controller (SMC) which provides an interface for external (off-chip) memory devices.

Key features are:

- Supports static memory-mapped devices including RAM, ROM, flash, burst ROM and external I/O devices.
- Asynchronous page-mode read operation in non-clocked memory subsystems.
- Asynchronous burst-mode read access to burst-mode ROM devices.
- Independent configuration for up to eight banks, each up to 16 MB.
- Programmable bus-turnaround (idle) cycles (one to 16).
- Programmable read and write wait states (up to 32), for static RAM devices.
- Programmable initial and subsequent burst-read wait state for burst-ROM devices.
- Programmable write protection.
- Programmable burst-mode operation.
- Programmable external data width: 8 bits, 16 bits or 32 bits.
- Programmable read-byte lane enable control.

6.9.1 Description

The SMC simultaneously supports up to eight independently configurable memory banks. Each memory bank can be 8 bits, 16 bits or 32 bits wide and is capable of supporting SRAM, ROM, burst-ROM memory, or external I/O devices.

A separate chip select output is available for each bank. The chip select lines are configurable to be active HIGH or LOW. Memory-bank selection is controlled by memory addressing. <u>Table 11</u> shows how the 32-bit system address is mapped to the external bus memory base addresses, chip selects, and bank internal addresses.

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32-bit system address bit field	Symbol	Description
31 to 29	BA[2:0]	external static-memory base address (three most significant bits); the base address can be found in the memory map; see <u>Ref. 1</u> . This field contains '010' when addressing an external memory bank.
28 to 26	CS[2:0]	chip select address space for eight memory banks; see Ref. 1.
25 and 24	-	always '00'; other values are 'mirrors' of the 16 MB bank address.
23 to 0	A[23:0]	16 MB memory banks address space

Table 11. External memory-bank address bit description

Table 12. External static-memory controller banks

CS[2:0]	Bank
000	bank 0
001	bank 1
010	bank 2
011	bank 3
100	bank 4
101	bank 5
110	bank 6
111	bank 7

6.9.2 Pin description

The external static-memory controller module in the LPC2917/2919/01 has the following pins, which are combined with other functions on the port pins of the LPC2917/2919/01. Table 13 shows the external memory controller pins.

Table 13. External memory controller pins

Symbol	Direction	Description	
EXTBUS CSx	OUT	memory-bank x select, x runs from 0 to 7	
EXTBUS BLSy	OUT	byte-lane select input y, y runs from 0 to 3	
EXTBUS WE	OUT	write enable (active LOW)	
EXTBUS OE	OUT	output enable (active LOW)	
EXTBUS A[23:0]	OUT	address bus	
EXTBUS D[31:0]	IN/OUT	data bus	

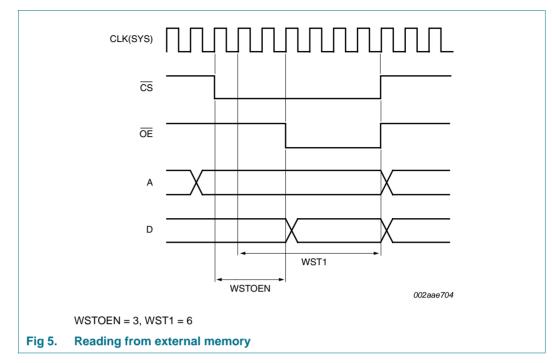
6.9.3 Clock description

The External Static-Memory Controller is clocked by CLK_SYS_SMC, see Section 6.7.2.

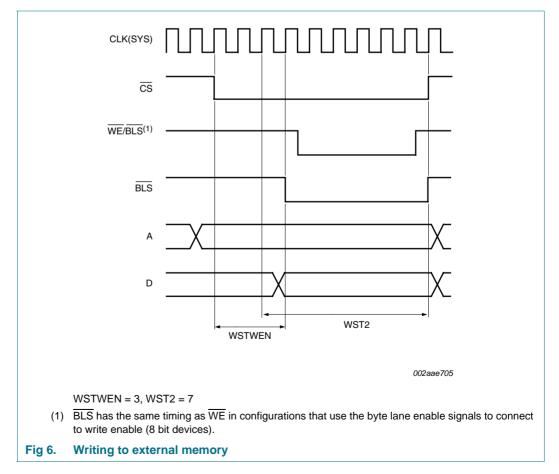
6.9.4 External memory timing diagrams

A timing diagram for reading from external memory is shown in <u>Figure 5</u>. The relationship between the wait-state settings is indicated with arrows.

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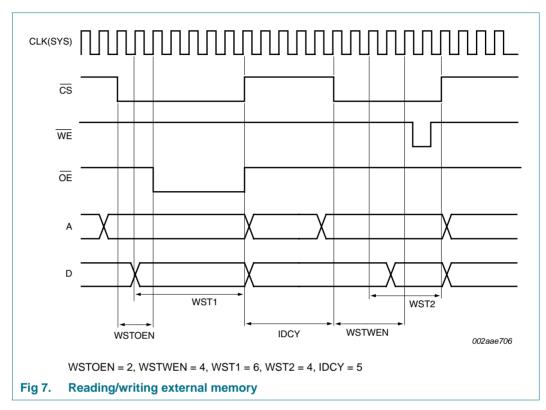
A timing diagram for writing to external memory is shown In <u>Figure 6</u>. The relationship between wait-state settings is indicated with arrows.



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ARM9 microcontroller with CAN and LIN

Usage of the idle/turn-around time (IDCY) is demonstrated In Figure 7. Extra wait states are added between a read and a write cycle in the same external memory device.



Address pins on the device are shared with other functions. When connecting external memories, check that the I/O pin is programmed for the correct function. Control of these settings is handled by the SCU.

6.10 DMA controller

The DMA controller allows peripheral-to memory, memory-to-peripheral, peripheral-to-peripheral, and memory-to-memory transactions. Each DMA stream provides unidirectional serial DMA transfers for a single source and destination. For example, a bidirectional port requires one stream for transmit and one for receives. The source and destination areas can each be either a memory region or a peripheral, and can be accessed through the same AHB master or one area by each master.

The DMA controls eight DMA channels with hardware prioritization. The DMA controller interfaces to the system via two AHB bus masters, each with a full 32-bit data bus width. DMA operations may be set up for 8-bit, 16-bit, and 32-bit data widths, and can be either big-endian or little-endian. Incrementing or non-incrementing addressing for source and destination are supported, as well as programmable DMA burst size. Scatter or gather DMA is supported through the use of linked lists. This means that the source and destination areas do not have to occupy contiguous areas of memory.

6.10.1 DMA support for peripherals

The GPDMA supports the following peripherals: SPI0/1/2 and UART0/1. The GPDMA can access both embedded SRAM blocks (16 kB and 32 kB), both TCMs, external static memory, and flash memory.

6.10.2 Clock description

The DMA controller is clocked by CLK_SYS_DMA derived from BASE_SYS_CLK, see <u>Section 6.7.2</u>.

6.11 General subsystem

6.11.1 General subsystem clock description

The general subsystem is clocked by CLK_SYS_GESS, see Section 6.7.2.

6.11.2 Chip and feature identification

The Chip/Feature ID (CFID) module contains registers which show and control the functionality of the chip. It contains an ID to identify the silicon and also registers containing information about the features enabled or disabled on the chip.

The key features are:

- Identification of product
- Identification of features enabled

The CFID has no external pins.

6.11.3 System Control Unit (SCU)

The system control unit contains system-related functions. The key feature is configuration of the I/O port-pins multiplexer. It defines the function of each I/O pin of the LPC2917/2919/01. The I/O pin configuration should be consistent with peripheral function usage.

The SCU has no external pins.

6.11.4 Event router

The event router provides bus-controlled routing of input events to the vectored interrupt controller for use as interrupt or wake-up signals.

Key features:

- Up to 19 level-sensitive external interrupt pins, including the receive pins of SPI, CAN, LIN, and UART, as well as the I²C-bus SCL pins plus three internal event sources.
- Input events can be used as interrupt source either directly or latched (edge-detected).
- Direct events disappear when the event becomes inactive.
- Latched events remain active until they are explicitly cleared.
- Programmable input level and edge polarity.
- Event detection maskable.
- Event detection is fully asynchronous, so no clock is required.

The event router allows the event source to be defined, its polarity and activation type to be selected and the interrupt to be masked or enabled. The event router can be used to start a clock on an external event.

The vectored interrupt-controller inputs are active HIGH.

6.11.4.1 Pin description

The event router module in the LPC2917/2919/01 is connected to the pins listed below. The pins are combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 14</u> shows the pins connected to the event router, and also the corresponding bit position in the event-router registers and the default polarity.

Table 14.	Event-router	pin connections
-----------	--------------	-----------------

Symbol	Direction	Description	Default polarity
EXTINT 7 - 0	IN	external interrupt input 7 - 0	1
CAN0 RXD	IN	CAN0 receive data input wake-up	0
CAN1 RXD	IN	CAN1 receive data input wake-up	0
I2C0_SCL	IN	I2C0 SCL clock input	0
I2C1_SCL	IN	I2C1 SCL clock input	0
LIN0 RXD	IN	LIN0 receive data input wake-up	0
LIN1 RXD	IN	LIN1 receive data input wake-up	0
SPI0 SDI	IN	SPI0 receive data input	0
SPI1 SDI	IN	SPI1 receive data input 0	
SPI2 SDI	IN	SPI2 receive data input	0
UART0 RXD	IN	UART0 receive data input	0
UART1 RXD	IN	UART1 receive data input	0
-	na	CAN interrupt (internal)	1
-	na	VIC FIQ (internal) 1	
-	na	VIC IRQ (internal)	1

6.12 Peripheral subsystem

6.12.1 Peripheral subsystem clock description

The peripheral subsystem is clocked by a number of different clocks:

- CLK_SYS_PESS
- CLK_UART0/1
- CLK_SPI0/1/2
- CLK_TMR0/1/2/3
- CLK_SAFE see Section 6.7.2

6.12.2 Watchdog timer

The purpose of the watchdog timer is to reset the ARM9 processor within a reasonable amount of time if the processor enters an error state. The watchdog generates a system reset if the user program fails to trigger it correctly within a predetermined amount of time.

Key features:

- Internal chip reset if not periodically triggered
- Timer counter register runs on always-on safe clock

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- Optional interrupt generation on watchdog time-out
- Debug mode with disabling of reset
- Watchdog control register change-protected with key
- Programmable 32-bit watchdog timer period with programmable 32-bit prescaler.

6.12.2.1 Functional description

The watchdog timer consists of a 32-bit counter with a 32-bit prescaler.

The watchdog should be programmed with a time-out value and then periodically restarted. When the watchdog times out, it generates a reset through the RGU.

To generate watchdog interrupts in watchdog debug mode the interrupt has to be enabled via the interrupt enable register. A watchdog-overflow interrupt can be cleared by writing to the clear-interrupt register.

Another way to prevent resets during debug mode is via the Pause feature of the watchdog timer. The watchdog is stalled when the ARM9 is in debug mode and the PAUSE_ENABLE bit in the watchdog timer control register is set.

The Watchdog Reset output is fed to the Reset Generator Unit (RGU). The RGU contains a reset source register to identify the reset source when the device has gone through a reset. See <u>Section 6.15.4</u>.

6.12.2.2 Clock description

The watchdog timer is clocked by two different clocks; CLK_SYS_PESS and CLK_SAFE, see <u>Section 6.7.2</u>. The register interface towards the system bus is clocked by CLK_SYS_PESS. The timer and prescale counters are clocked by CLK_SAFE which is always on.

6.12.3 Timer

The LPC2917/2919/01 contains six identical timers: four in the peripheral subsystem and two in the Modulation and Sampling Control SubSystem (MSCSS) located at different peripheral base addresses. This section describes the four timers in the peripheral subsystem. Each timer has four capture inputs and/or match outputs. Connection to device pins depends on the configuration programmed into the port function-select registers. The two timers located in the MSCSS have no external capture or match pins, but the memory map is identical, see <u>Section 6.14.6</u>. One of these timers has an external input for a pause function.

The key features are:

- 32-bit timer/counter with programmable 32-bit prescaler
- Up to four 32-bit capture channels per timer. These take a snapshot of the timer value when an external signal connected to the TIMERx CAPn input changes state. A capture event may also optionally generate an interrupt
- Four 32-bit match registers per timer that allow:
 - Continuous operation with optional interrupt generation on match
 - Stop timer on match with optional interrupt generation
 - Reset timer on match with optional interrupt generation

- Up to four external outputs per timer corresponding to match registers, with the following capabilities:
 - Set LOW on match
 - Set HIGH on match
 - Toggle on match
 - Do nothing on match
- Pause input pin (MSCSS timers only)

The timers are designed to count cycles of the clock and optionally generate interrupts or perform other actions at specified timer values, based on four match registers. They also include capture inputs to trap the timer value when an input signal changes state, optionally generating an interrupt. The core function of the timers consists of a 32 bit prescale counter triggering the 32 bit timer counter. Both counters run on clock CLK_TMRx (x runs from 0 to 3) and all time references are related to the period of this clock. Note that each timer has its individual clock source within the Peripheral SubSystem. In the Modulation and Sampling SubSystem each timer also has its own individual clock source. See section <u>Section 6.15.5</u> for information on generation of these clocks.

6.12.3.1 Pin description

Table 45 Timer nine

The four timers in the peripheral subsystem of the LPC2917/2919/01 have the pins described below. The two timers in the modulation and sampling subsystem have no external pins except for the pause pin on MSCSS timer 1. See <u>Section 6.14.6</u> for a description of these timers and their associated pins. The timer pins are combined with other functions on the port pins of the LPC2917/2919/01, see <u>Section 6.11.3</u>. Table <u>Table 15</u> shows the timer pins (x runs from 0 to 3).

Symbol	Pin name	Direction	Description
TIMERx CAP[0]	CAPx[0]	IN	TIMER x capture input 0
TIMERx CAP[1]	CAPx[1]	IN	TIMER x capture input 1
TIMERx CAP[2]	CAPx[2]	IN	TIMER x capture input 2
TIMERx CAP[3]	CAPx[3]	IN	TIMER x capture input 3
TIMERx MAT[0]	MATx[0]	OUT	TIMER x match output 0
TIMERx MAT[1]	MATx[1]	OUT	TIMER x match output 1
TIMERx MAT[2]	MATx[2]	OUT	TIMER x match output 2
TIMERx MAT[3]	MATx[3]	OUT	TIMER x match output 3

6.12.3.2 Clock description

The timer modules are clocked by two different clocks; CLK_SYS_PESS and CLK_TMRx (x = 0-3), see Section 6.7.2. Note that each timer has its own CLK_TMRx branch clock for power management. The frequency of all these clocks is identical as they are derived from the same base clock BASE_CLK_TMR. The register interface towards the system bus is clocked by CLK_SYS_PESS. The timer and prescale counters are clocked by CLK_TMRx.

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6.12.4 UARTs

The LPC2917/2919/01 contains two identical UARTs located at different peripheral base addresses. The key features are:

- 16-byte receive and transmit FIFOs.
- Register locations conform to 550 industry standard.
- Receiver FIFO trigger points at 1 byte, 4 bytes, 8 bytes and 14 bytes.
- Built-in baud rate generator.
- Support for RS-485/9-bit mode allows both software address detection and automatic address detection using 9-bit mode.

The UART is commonly used to implement a serial interface such as RS232. The LPC2917/2919/01 contains two industry-standard 550 UARTs with 16-byte transmit and receive FIFOs, but they can also be put into 450 mode without FIFOs.

6.12.4.1 Pin description

The UART pins are combined with other functions on the port pins of the LPC2917/2919/01. Table 16 shows the UART pins (x runs from 0 to 1).

Table 16. UART pins				
Symbol	Pin name	Direction	Description	
UARTx TXD	TXDx	OUT	UART channel x transmit data output	
UARTx RXD	RXDx	IN	UART channel x receive data input	

6.12.4.2 Clock description

The UART modules are clocked by two different clocks; CLK_SYS_PESS and CLK_UARTx (x = 0-1), see <u>Section 6.7.2</u>. Note that each UART has its own CLK_UARTx branch clock for power management. The frequency of all CLK_UARTx clocks is identical since they are derived from the same base clock BASE_CLK_UART. The register interface towards the system bus is clocked by CLK_SYS_PESS. The baud generator is clocked by the CLK_UARTx.

6.12.5 Serial peripheral interface (SPI)

The LPC2917/2919/01 contains three Serial Peripheral Interface modules (SPIs) to allow synchronous serial communication with slave or master peripherals.

The key features are:

- Master or slave operation
- Each SPI supports up to four slaves in sequential multi-slave operation
- Supports timer-triggered operation
- Programmable clock bit rate and prescale based on SPI source clock (BASE_SPI_CLK), independent of system clock
- Separate transmit and receive FIFO memory buffers; 16 bits wide, 32 locations deep
- Programmable choice of interface operation: Motorola SPI or Texas Instruments Synchronous Serial Interfaces
- Programmable data-frame size from 4 to 16 bits

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- Independent masking of transmit FIFO, receive FIFO and receive overrun interrupts
- Serial clock-rate master mode: fserial $clk \leq f_{clk(SPI)}/2$
- Serial clock-rate slave mode: fserial clk = f_{clk(SPI)}/4
- Internal loopback test mode

The SPI module can operate in:

- Master mode:
 - Normal transmission mode
 - Sequential slave mode
- Slave mode

6.12.5.1 Functional description

The SPI module is a master or slave interface for synchronous serial communication with peripheral devices that have either Motorola SPI or Texas Instruments Synchronous Serial Interfaces.

The SPI module performs serial-to-parallel conversion on data received from a peripheral device. The transmit and receive paths are buffered with FIFO memories (16 bits wide \times 32 words deep). Serial data is transmitted on pins SDOx and received on pins SDIx.

The SPI module includes a programmable bit-rate clock divider and prescaler to generate the SPI serial clock from the input clock CLK_SPIx.

The SPI module's operating mode, frame format, and word size are programmed through the SLVn_SETTINGS registers.

A single combined interrupt request SPI_INTREQ output is asserted if any of the interrupts are asserted and unmasked.

Depending on the operating mode selected, the SPI SCS outputs operate as an active-HIGH frame synchronization output for Texas Instruments synchronous serial frame format or an active LOW chip select for SPI.

Each data frame is between four and 16 bits long, depending on the size of words programmed, and is transmitted starting with the MSB.

6.12.5.2 Pin description

The SPI pins are combined with other functions on the port pins of the LPC2917/2919/01, see Section 6.11.3. Table 17 shows the SPI pins (x runs from 0 to 2; y runs from 0 to 3).

Table 17. SPI pins				
Symbol	Pin name	Direction	Description	
SPIx SCSy	SCSx[y]	IN/OUT	SPIx chip select ^{[1][2]}	
SPIx SCK	SCKx	IN/OUT	SPIx clock ^[1]	
SPIx SDI	SDIx	IN	SPIx data input	
SPIx SDO	SDOx	OUT	SPIx data output	

[1] Direction of SPIx SCS and SPIx SCK pins depends on master or slave mode. These pins are output in master mode, input in slave mode.

In slave mode there is only one chip select input pin, SPIx SCS0. The other chip selects have no function in [2] slave mode.

6.12.5.3 Clock description

The SPI modules are clocked by two different clocks; CLK_SYS_PESS and CLK_SPIx (x = 0, 1, 2), see <u>Section 6.7.2</u>. Note that each SPI has its own CLK_SPIx branch clock for power management. The frequency of all clocks CLK_SPIx is identical as they are derived from the same base clock BASE_CLK_SPI. The register interface towards the system bus is clocked by CLK_SYS_PESS. The serial-clock rate divisor is clocked by CLK_SPIx.

The SPI clock frequency can be controlled by the CGU. In master mode the SPI clock frequency (CLK_SPIx) must be set to at least twice the SPI serial clock rate on the interface. In slave mode CLK_SPIx must be set to four times the SPI serial clock rate on the interface.

6.12.6 General-purpose I/O

The LPC2917/2919/01 contains four general-purpose I/O ports located at different peripheral base addresses. All I/O pins are bidirectional, and the direction can be programmed individually. The I/O pad behavior depends on the configuration programmed in the port function-select registers.

The key features are:

- · General-purpose parallel inputs and outputs
- Direction control of individual bits
- Synchronized input sampling for stable input-data values
- All I/O defaults to input at reset to avoid any possible bus conflicts

6.12.6.1 Functional description

The general-purpose I/O provides individual control over each bidirectional port pin. There are two registers to control I/O direction and output level. The inputs are synchronized to achieve stable read-levels.

To generate an open-drain output, set the bit in the output register to the desired value. Use the direction register to control the signal. When set to output, the output driver actively drives the value on the output: when set to input the signal floats and can be pulled up internally or externally.

6.12.6.2 Pin description

The five GPIO ports in the LPC2917/2919/01 have the pins listed below. The GPIO pins are combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 18</u> shows the GPIO pins.

Table To. GFIO pins				
Symbol	Pin name	Direction	Description	
GPIO0 pin[31:0]	P0[31:0]	IN/OUT	GPIO port x pins 31 to 0	
GPIO1 pin[31:0]	P1[31:0]	IN/OUT	GPIO port x pins 31 to 0	
GPIO2 pin[27:0]	P2[27:0]	IN/OUT	GPIO port x pins 27 to 0	
GPIO3 pin[15:0]	P3[15:0]	IN/OUT	GPIO port x pins 15 to 0	

Table 18. GPIO pins

6.12.6.3 Clock description

The GPIO modules are clocked by several clocks, all of which are derived from BASE_SYS_CLK; CLK_SYS_PESS and CLK_SYS_GPIOx (x = 0, 1, 2, 3), see <u>Section 6.7.2</u>. Note that each GPIO has its own CLK_SYS_GPIOx branch clock for power management. The frequency of all clocks CLK_SYS_GPIOx is identical to CLK_SYS_PESS since they are derived from the same base clock BASE_SYS_CLK.

6.13 Networking subsystem

6.13.1 CAN gateway

Controller Area Network (CAN) is the definition of a high-performance communication protocol for serial data communication. The two CAN controllers in the LPC2917/2919/01 provide a full implementation of the CAN protocol according to the *CAN specification version 2.0B*. The gateway concept is fully scalable with the number of CAN controllers, and always operates together with a separate powerful and flexible hardware acceptance filter.

The key features are:

- Supports 11-bit as well as 29-bit identifiers
- Double receive buffer and triple transmit buffer
- Programmable error-warning limit and error counters with read/write access
- · Arbitration-lost capture and error-code capture with detailed bit position
- Single-shot transmission (i.e. no re-transmission)
- Listen-only mode (no acknowledge; no active error flags)
- Reception of 'own' messages (self-reception request)
- FullCAN mode for message reception

6.13.1.1 Global acceptance filter

The global acceptance filter provides look-up of received identifiers - called acceptance filtering in CAN terminology - for all the CAN controllers. It includes a CAN ID look-up table memory, in which software maintains one to five sections of identifiers. The CAN ID look-up table memory is 2 kB large (512 words, each of 32 bits). It can contain up to 1024 standard frame identifiers or 512 extended frame identifiers or a mixture of both types. It is also possible to define identifier groups for standard and extended message formats.

6.13.1.2 Pin description

The two CAN controllers in the LPC2917/2919/01 have the pins listed below. The CAN pins are combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 19</u> shows the CAN pins (x runs from 0 to 1).

Table 19. CAN pins					
Symbol	Pin name	Direction	Description		
CANx TXD	TXDC0/1	OUT	CAN channel x transmit data output		
CANx RXD	RXDC0/1	IN	CAN channel x receive data input		

6.13.2 LIN

The LPC2917/2919/01 contain two LIN 2.0 master controllers. These can be used as dedicated LIN 2.0 master controllers with additional support for sync break generation and with hardware implementation of the LIN protocol according to spec 2.0.

Remark: Both LIN channels can be also configured as UART channels.

The key features are:

- Complete LIN 2.0 message handling and transfer
- One interrupt per LIN message
- Slave response time-out detection
- Programmable sync-break length
- Automatic sync-field and sync-break generation
- Programmable inter-byte space
- Hardware or software parity generation
- Automatic checksum generation
- Fault confinement
- Fractional baud rate generator

6.13.2.1 Pin description

The two LIN 2.0 master controllers in the LPC2917/2919/01 have the pins listed below. The LIN pins are combined with other functions on the port pins of the LPC2917/2919/01. Table 20 shows the LIN pins. For more information see <u>Ref. 1</u> subsection 3.43, LIN master controller.

Table 20. LIN controller pins

Symbol	Pin name	Direction	Description	
LIN0/1 TXD	TXDL0/1	OUT	LIN channel 0/1 transmit data output	
LIN0/1 RXD	RXDL0/1	IN	LIN channel 0/1 receive data input	

6.13.3 I²C-bus serial I/O controllers

The LPC2917/2919/01 each contain two I²C-bus controllers.

The I²C-bus is bidirectional for inter-IC control using only two wires: a serial clock line (SCL) and a serial data line (SDA). Each device is recognized by a unique address and can operate as either a receiver-only device (e.g., an LCD driver) or as a transmitter with the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either master or slave mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I²C is a multi-master bus, and it can be controlled by more than one bus master connected to it.

The main features if the I²C-bus interfaces are:

- I²C0 and I²C1 use standard I/O pins with bit rates of up to 400 kbit/s (Fast I²C-bus) and do not support powering off of individual devices connected to the same bus lines.
- Easy to configure as master, slave, or master/slave.

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- Programmable clocks allow versatile rate control.
- Bidirectional data transfer between masters and slaves.
- Multi-master bus (no central master).
- Arbitration between simultaneously transmitting masters without corruption of serial data on the bus.
- Serial clock synchronization allows devices with different bit rates to communicate via one serial bus.
- Serial clock synchronization can be used as a handshake mechanism to suspend and resume serial transfer.
- The I²C-bus can be used for test and diagnostic purposes.
- All I²C-bus controllers support multiple address recognition and a bus monitor mode.

6.13.3.1 Pin description

Table 21.I²C-bus pins^[1]

Symbol	Pin name	Direction	Description
I2C SCL0/1	SCL0/1	I/O	I2C clock input/output
I2C SDA0/1	SDA0/1	I/O	I2C data input/output

[1] Note that the pins are not I²C-bus compliant open-drain pins.

6.14 Modulation and sampling control subsystem

The Modulation and Sampling Control Subsystem (MSCSS) in the LPC2917/2919/01 includes four Pulse-Width Modulators (PWMs), two 10-bit successive approximation Analog-to-Digital Converters (ADCs) and two timers.

The key features of the MSCSS are:

- Two 10-bit, 400 ksamples/s, 8-channel ADCs with 3.3 V inputs and various triggerstart options
- Four 6-channel PWMs (Pulse-Width Modulators) with capture and trap functionality
- Two dedicated timers to schedule and synchronize the PWMs and ADCs
- Quadrature encoder interface

6.14.1 Functional description

The MSCSS contains Pulse-Width Modulators (PWMs), Analog-to-Digital Converters (ADCs) and timers.

Figure 8 provides an overview of the MSCSS. An AHB-to-APB bus bridge takes care of communication with the AHB system bus. Two internal timers are dedicated to this subsystem. MSCSS timer 0 can be used to generate start pulses for the ADCs and the first PWM. The second timer (MSCSS timer 1) is used to generate 'carrier' signals for the PWMs. These carrier patterns can be used, for example, in applications requiring current control. Several other trigger possibilities are provided for the ADCs (external, cascaded or following a PWM). The capture inputs of both timers can also be used to capture the start pulse of the ADCs.

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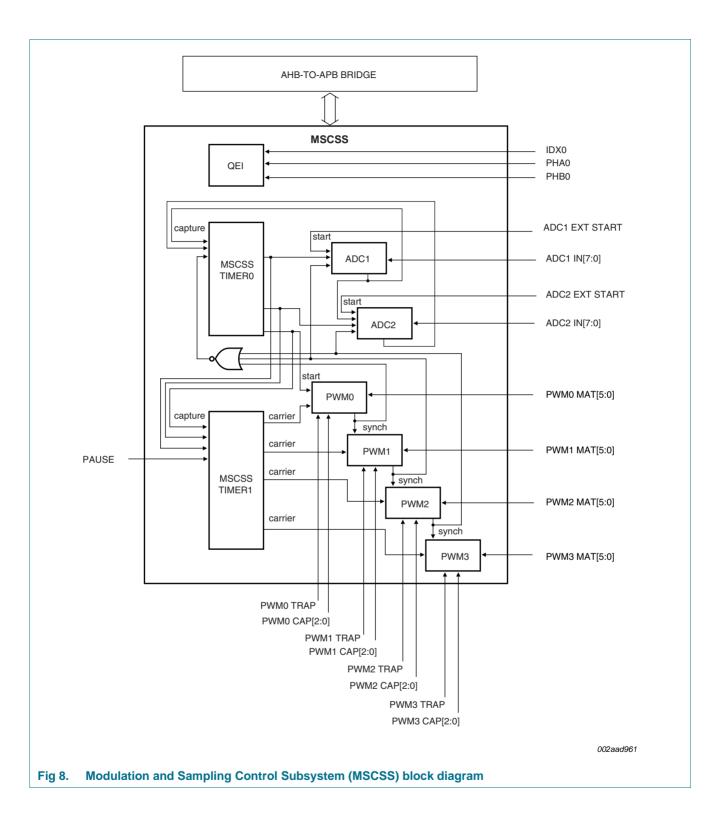
The PWMs can be used to generate waveforms in which the frequency, duty cycle and rising and falling edges can be controlled very precisely. Capture inputs are provided to measure event phases compared to the main counter. Depending on the applications, these inputs can be connected to digital sensor motor outputs or digital external signals. Interrupt signals are generated on several events to closely interact with the CPU.

The ADCs can be used for any application needing accurate digitized data from analog sources. To support applications like motor control, a mechanism to synchronize several PWMs and ADCs is available (sync_in and sync_out).

Note that the PWMs run on the PWM clock and the ADCs on the ADC clock, see <u>Section 6.15.2</u>.

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6.14.2 Pin description

The pins of the LPC2917/2919/01 MSCSS associated with the two ADC modules are described in <u>Section 6.14.4.2</u>. Pins connected to the four PWM modules are described in <u>Section 6.14.5.4</u>, pins directly connected to the MSCSS timer 1 module are described in <u>Section 6.14.6.1</u>, and pins connected to the quadrature encoder interface are described in <u>Section 6.14.7.1</u>.

6.14.3 Clock description

The MSCSS is clocked from a number of different sources:

- CLK_SYS_MSCSS_A clocks the AHB side of the AHB-to-APB bus bridge
- CLK_MSCSS_APB clocks the subsystem APB bus
- CLK_MSCSS_MTMR0/1 clocks the timers
- CLK_MSCSS_PWM0..3 clocks the PWMs.

Each ADC has two clock areas; a APB part clocked by CLK_MSCSS_ADCx_APB (x = 1 or 2) and a control part for the analog section clocked by CLK_ADCx = 1 or 2), see <u>Section 6.7.2</u>.

All clocks are derived from the BASE_MSCSS_CLK, except for CLK_SYS_MSCSS_A which is derived form BASE_SYS_CLK, and the CLK_ADCx clocks which are derived from BASE_CLK_ADC. If specific PWM or ADC modules are not used their corresponding clocks can be switched off.

6.14.4 Analog-to-digital converter

The MSCSS in the LPC2917/2919/01 includes two 10-bit successive-approximation analog-to-digital converters.

The key features of the ADC interface module are:

- ADC1 and ADC2: Eight analog inputs; time-multiplexed; measurement range up to 3.3 V
- External reference-level inputs
- 400 ksamples per second at 10-bit resolution up to 1500 ksamples per second at 2-bit resolution
- Programmable resolution from 2-bit to 10-bit
- Single analog-to-digital conversion scan mode and continuous analog-to-digital conversion scan mode
- Optional conversion on transition on external start input, timer capture/match signal, PWM_sync or 'previous' ADC
- Converted digital values are stored in a register for each channel
- Optional compare condition to generate a 'less than' or an 'equal to or greater than' compare-value indication for each channel
- Power-down mode

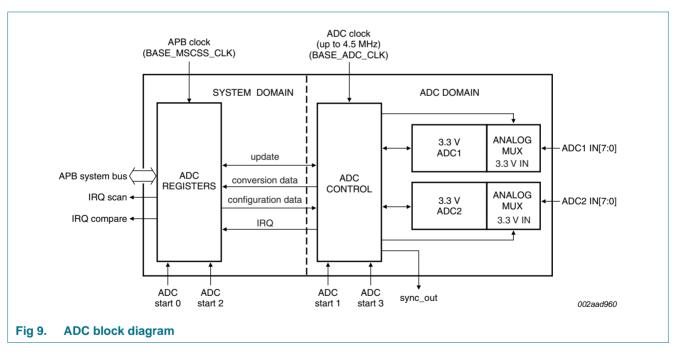
6.14.4.1 Functional description

The ADC block diagram, Figure 9, shows the basic architecture of each ADC. The ADC functionality is divided into two major parts; one part running on the MSCSS Subsystem clock, the other on the ADC clock. This split into two clock domains affects the behavior from a system-level perspective. The actual analog-to-digital conversions take place in the ADC clock domain, but system control takes place in the system clock domain.

A mechanism is provided to modify configuration of the ADC and control the moment at which the updated configuration is transferred to the ADC domain.

The ADC clock is limited to 4.5 MHz maximum frequency and should always be lower than or equal to the system clock frequency. To meet this constraint or to select the desired lower sampling frequency, the clock generation unit provides a programmable fractional system-clock divider dedicated to the ADC clock. Conversion rate is determined by the ADC clock frequency divided by the number of resolution bits plus one. Accessing ADC registers requires an enabled ADC clock, which is controllable via the clock generation unit, see Section 6.15.2.

Each ADC has four start inputs. Note that start 0 and start 2 are captured in the system clock domain while start 1 and start 3 are captured in the ADC domain. The start inputs are connected at MSCSS level, see Figure 8 for details.



6.14.4.2 Pin description

The two ADC modules in the MSCSS have the pins described below. The ADCx input pins are combined with other functions on the port pins of the LPC2917/2919/01. The VREFN and VREFP pins are common for both ADCs. <u>Table 22</u> shows the ADC pins.

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Table 22. Analog t	o digital conve	erter pins	
Symbol	Pin name	Direction	Description
ADC1/2 IN[7:0]	IN1/2[7:0]	IN	analog input for 3.3 V ADC1/2, channel 7 to channel 0
ADCn_EXT_START	CAP1[n]	IN	ADC external start-trigger input (n = 1 or 2)
VREFN	VREFN	IN	ADC LOW reference level
VREFP	VREFP	IN	ADC HIGH reference level

. . . .

Remark: Note that the ADC1 and ADC2 accept an input voltage up to of 3.6 V (see Table 33) on the ADC1/2 IN pins. If the ADC is not used, the pins are 5 V tolerant.

6.14.4.3 Clock description

The ADC modules are clocked from two different sources; CLK MSCSS ADCx APB and CLK ADCx (x = 1 or 2), see Section 6.7.2. Note that each ADC has its own CLK ADCx and CLK MSCSS ADCx APB branch clocks for power management. If an ADC is unused both its CLK MSCSS ADCx APB and CLK ADCx can be switched off.

The frequency of all the CLK MSCSS ADCx APB clocks is identical to CLK_MSCSS_APB since they are derived from the same base clock BASE MSCSS CLK. Likewise the frequency of all the CLK ADCx clocks is identical since they are derived from the same base clock BASE ADC CLK.

The register interface towards the system bus is clocked by CLK MSCSS ADCx APB. Control logic for the analog section of the ADC is clocked by CLK ADCx, see also Figure 9.

6.14.5 Pulse Width Modulator (PWM)

The MSCSS in the LPC2917/2919/01 includes four PWM modules with the following features.

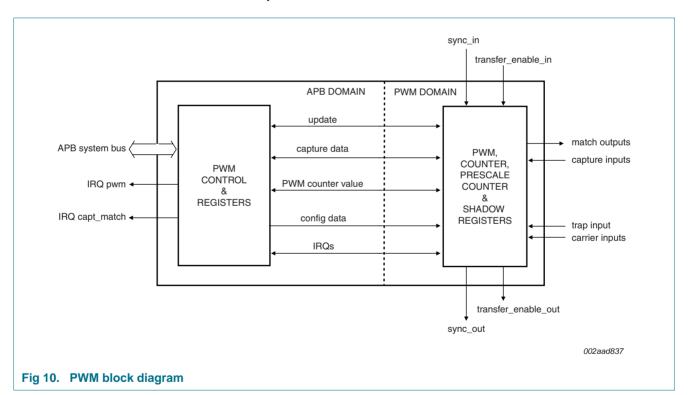
- Six pulse-width modulated output signals
- Double edge features (rising and falling edges programmed individually)
- Optional interrupt generation on match (each edge)
- Different operation modes: continuous or run-once
- 16-bit PWM counter and 16-bit prescale counter allow a large range of PWM periods
- A protective mode (TRAP) holding the output in a software-controllable state and with optional interrupt generation on a trap event
- Three capture registers and capture trigger pins with optional interrupt generation on a capture event
- Interrupt generation on match event, capture event, PWM counter overflow or trap event
- A burst mode mixing the external carrier signal with internally generated PWM
- Programmable sync-delay output to trigger other PWM modules (master/slave behavior)

6.14.5.1 Functional description

The ability to provide flexible waveforms allows PWM blocks to be used in multiple applications; e.g. dimmer/lamp control and fan control. Pulse-width modulation is the preferred method for regulating power since no additional heat is generated, and it is energy-efficient when compared with linear-regulating voltage control networks.

The PWM delivers the waveforms/pulses of the desired duty cycles and cycle periods. A very basic application of these pulses can be in controlling the amount of power transferred to a load. Since the duty cycle of the pulses can be controlled, the desired amount of power can be transferred for a controlled duration. Two examples of such applications are:

- Dimmer controller: The flexibility of providing waves of a desired duty cycle and cycle period allows the PWM to control the amount of power to be transferred to the load. The PWM functions as a dimmer controller in this application
- Motor controller: The PWM provides multi-phase outputs, and these outputs can be controlled to have a certain pattern sequence. In this way the force/torque of the motor can be adjusted as desired. This makes the PWM function as a motor drive.



The PWM block diagram in Figure 10 shows the basic architecture of each PWM. PWM functionality is split into two major parts, a APB domain and a PWM domain, both of which run on clocks derived from the BASE_MSCSS_CLK. This split into two domains affects behavior from a system-level perspective. The actual PWM and prescale counters are located in the PWM domain but system control takes place in the APB domain.

The actual PWM consists of two counters; a 16-bit prescale counter and a 16-bit PWM counter. The position of the rising and falling edges of the PWM outputs can be programmed individually. The prescale counter allows high system bus frequencies to be scaled down to lower PWM periods. Registers are available to capture the PWM counter values on external events.

Note that in the Modulation and Sampling SubSystem, each PWM has its individual clock source CLK_MSCSS_PWMx (x runs from 0 to 3). Both the prescale and the timer counters within each PWM run on this clock CLK_MSCSS_PWMx, and all time references are related to the period of this clock. See <u>Section 6.15</u> for information on generation of these clocks.

6.14.5.2 Synchronizing the PWM counters

A mechanism is included to synchronize the PWM period to other PWMs by providing a sync input and a sync output with programmable delay. Several PWMs can be synchronized using the trans_enable_in/trans_enable_out and sync_in/sync_out ports. See Figure 8 for details of the connections of the PWM modules within the MSCSS in the LPC2917/2919/01. PWM 0 can be master over PWM 1; PWM 1 can be master over PWM 2, etc.

6.14.5.3 Master and slave mode

A PWM module can provide synchronization signals to other modules (also called Master mode). The signal sync_out is a pulse of one clock cycle generated when the internal PWM counter (re)starts. The signal trans_enable_out is a pulse synchronous to sync_out, generated if a transfer from system registers to PWM shadow registers occurred when the PWM counter restarted. A delay may be inserted between the counter start and generation of trans_enable_out and sync_out.

A PWM module can use input signals trans_enable_in and sync_in to synchronize its internal PWM counter and the transfer of shadow registers (Slave mode).

6.14.5.4 Pin description

Each of the four PWM modules in the MSCSS has the following pins. These are combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 23</u> shows the PWM0 to PWM3 pins.

Symbol	Pin name	Direction	Description
PWMn CAP[0]	PCAPn[0]	IN	PWM n capture input 0
PWMn CAP[1]	PCAPn[1]	IN	PWM n capture input 1
PWMn CAP[2]	PCAPn[2]	IN	PWM n capture input 2
PWMn MAT[0]	PMATn[0]	OUT	PWM n match output 0
PWMn MAT[1]	PMATn[1]	OUT	PWM n match output 1
PWMn MAT[2]	PMATn[2]	OUT	PWM n match output 2
PWMn MAT[3]	PMATn[3]	OUT	PWM n match output 3
PWMn MAT[4]	PMATn[4]	OUT	PWM n match output 4
PWMn MAT[5]	PMATn[5]	OUT	PWM n match output 5
PWMn TRAP	TRAPn	IN	PWM n trap input

Table 23. PWM pins

6.14.5.5 Clock description

The PWM modules are clocked by CLK_MSCSS_PWMx (x = 0 - 3), see <u>Section 6.7.2</u>. Note that each PWM has its own CLK_MSCSS_PWMx branch clock for power management. The frequency of all these clocks is identical to CLK_MSCSS_APB since they are derived from the same base clock BASE_MSCSS_CLK.

Also note that unlike the timer modules in the Peripheral SubSystem, the actual timer counter registers of the PWM modules run at the same clock as the APB system interface CLK_MSCSS_APB. This clock is independent of the AHB system clock.

If a PWM module is not used its CLK_MSCSS_PWMx branch clock can be switched off.

6.14.6 Timers in the MSCSS

The two timers in the MSCSS are functionally identical to the timers in the peripheral subsystem, see <u>Section 6.12.3</u>. The features of the timers in the MSCSS are the same as the timers in the peripheral subsystem, but the capture inputs and match outputs are not available on the device pins. These signals are instead connected to the ADC and PWM modules as outlined in the description of the MSCSS, see <u>Section 6.14.1</u>.

See section <u>Section 6.12.3</u> for a functional description of the timers.

6.14.6.1 Pin description

MSCSS timer 0 has no external pins.

MSCSS timer 1 has a PAUSE pin available as external pin. The PAUSE pin is combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 24</u> shows the MSCSS timer 1 external pin.

Table 24. MSCSS timer 1 pin

Symbol	Direction	Description
MSCSS PAUSE	IN	pause pin for MSCSS timer 1

6.14.6.2 Clock description

The Timer modules in the MSCSS are clocked by CLK_MSCSS_MTMRx (x = 0 to 1), see <u>Section 6.7.2</u>. Note that each timer has its own CLK_MSCSS_MTMRx branch clock for power management. The frequency of all these clocks is identical to CLK_MSCSS_APB since they are derived from the same base clock BASE_MSCSS_CLK.

Note that, unlike the timer modules in the Peripheral SubSystem, the actual timer counter registers run at the same clock as the APB system interface CLK_MSCSS_APB. This clock is independent of the AHB system clock.

If a timer module is not used its CLK_MSCSS_MTMRx branch clock can be switched off.

6.14.7 Quadrature Encoder Interface (QEI)

A quadrature encoder, also known as a 2-channel incremental encoder, converts angular displacement into two pulse signals. By monitoring both the number of pulses and the relative phase of the two signals, the user can track the position, direction of rotation, and velocity. In addition, a third channel, or index signal, can be used to reset the position counter. The quadrature encoder interface decodes the digital pulses from a quadrature encoder wheel to integrate position over time and determine direction of rotation. In addition, the QEI can capture the velocity of the encoder wheel.

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The QEI has the following features:

- Tracks encoder position.
- Increments/ decrements depending on direction.
- Programmable for 2X or 4X position counting.
- Velocity capture using built-in timer.
- Velocity compare function with less than interrupt.
- Uses 32-bit registers for position and velocity.
- Three position compare registers with interrupts.
- Index counter for revolution counting.
- Index compare register with interrupts.
- Can combine index and position interrupts to produce an interrupt for whole and partial revolution displacement.
- Digital filter with programmable delays for encoder input signals.
- Can accept decoded signal inputs (clk and direction).
- Connected to APB.

6.14.7.1 Pin description

The QEI module in the MSCSS has the following pins. These are combined with other functions on the port pins of the LPC2917/2919/01. <u>Table 25</u> shows the QEI pins.

	i pino		
Symbol	Pin name	Direction	Description
QEI0 IDX	IDX0	IN	Index signal. Can be used to reset the position.
QEI0 PHA	PHA0	IN	Sensor signal. Corresponds to PHA in quadrature mode and to direction in clock/direction mode.
QEI0 PHB	PHB0	IN	Sensor signal. Corresponds to PHB in quadrature mode and to clock signal in clock/direction mode.

Table 25. QEI pins

6.14.7.2 Clock description

The QEI module is clocked by CLK_MSCSS_QEI, see <u>Section 6.7.2</u>. The frequency of this clock is identical to CLK_MSCSS_APB since they are derived from the same base clock BASE MSCSS CLK.

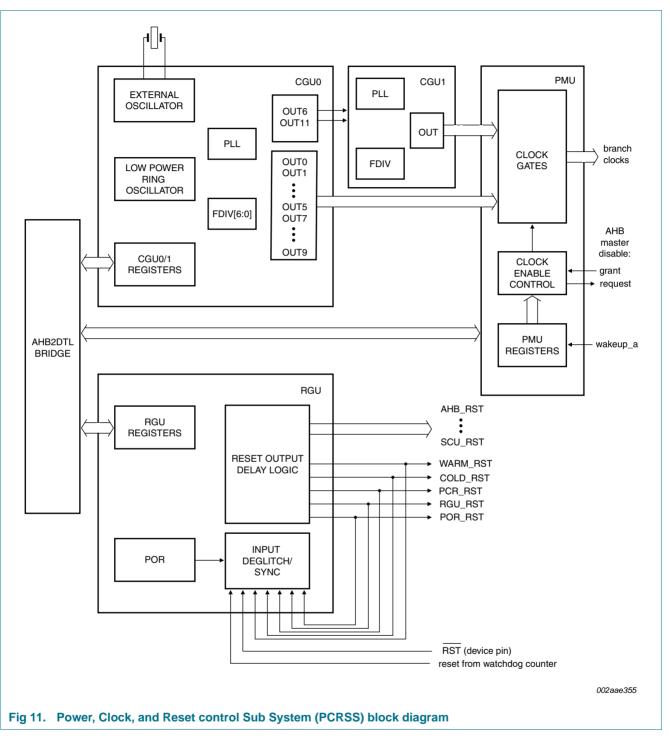
If the QEI is not used its CLK_MSCSS_QEI branch clock can be switched off.

6.15 Power, clock and reset control subsystem

The Power, Clock, and Reset Control Subsystem (PCRSS) in the LPC2917/2919/01 includes the Clock Generator Units (CGU0 and CGU1), a Reset Generator Unit (RGU) and a Power Management Unit (PMU).

Figure 11 provides an overview of the PCRSS. An AHB-to-DTL bridge provides communication with the AHB system bus.

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6.15.1 Clock description

The PCRSS is clocked by a number of different clocks. CLK_SYS_PCRSS clocks the AHB side of the AHB to DTL bus bridge and CLK_PCR_SLOW clocks the CGU, RGU and PMU internal logic, see <u>Section 6.7.2</u>. CLK_SYS_PCRSS is derived from BASE_SYS_CLK, which can be switched off in low-power modes. CLK_PCR_SLOW is derived from BASE_PCR_CLK and is always on in order to be able to wake up from low-power modes.

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6.15.2 Clock Generation Unit (CGU0)

The key features are:

- Generation of 11 base clocks, selectable from several embedded clock sources.
- Crystal oscillator with power-down.
- Control PLL with power-down.
- Very low-power ring oscillator, always on to provide a 'safe clock'.
- Seven fractional clock dividers with L/D division.
- Individual source selector for each base clock, with glitch-free switching.
- Autonomous clock-activity detection on every clock source.
- Protection against switching to invalid or inactive clock sources.
- Embedded frequency counter.
- Register write-protection mechanism to prevent unintentional alteration of clocks.

Remark: Any clock-frequency adjustment has a direct impact on the timing of all on-board peripherals.

6.15.2.1 Functional description

The clock generation unit provides 11 internal clock sources as described in Table 26.

Table 26.	CGU0 base clocks		
Number	Name	Frequency (MHz) [<u>1]</u>	Description
0	BASE_SAFE_CLK	0.4	base safe clock (always on)
1	BASE_SYS_CLK	125	base system clock
2	BASE_PCR_CLK	0.4 [2]	base PCR subsystem clock
3	BASE_IVNSS_CLK	125	base IVNSS subsystem clock
4	BASE_MSCSS_CLK	125	base MSCSS subsystem clock
5	BASE_UART_CLK	125	base UART clock
6	BASE_ICLK0_CLK	125	base internal clock 0, for CGU1
7	BASE_SPI_CLK	50	base SPI clock
8	BASE_TMR_CLK	125	base timers clock
9	BASE_ADC_CLK	4.5	base ADCs clock
10	reserved	-	-
11	BASE_ICLK1_CLK	125	base internal clock 1, for CGU1

[1] Maximum frequency that guarantees stable operation of the LPC2917/2919/01.

[2] Fixed to low-power oscillator.

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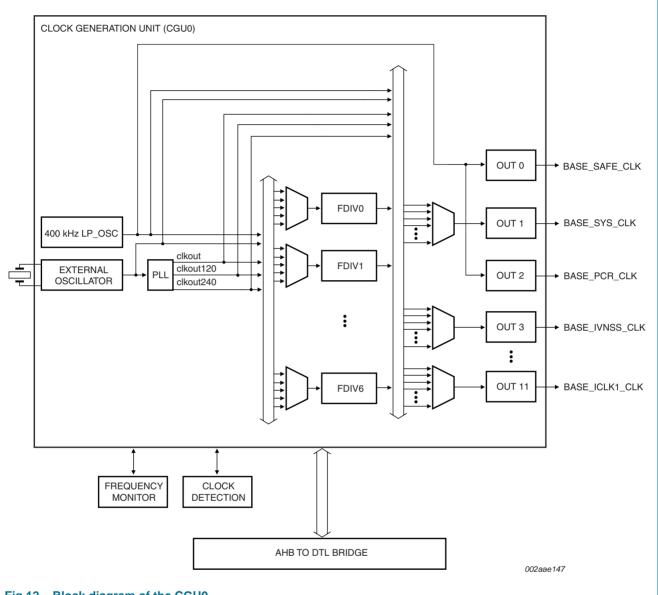


Fig 12. Block diagram of the CGU0

For generation of these base clocks, the CGU consists of primary and secondary clock generators and one output generator for each base clock.

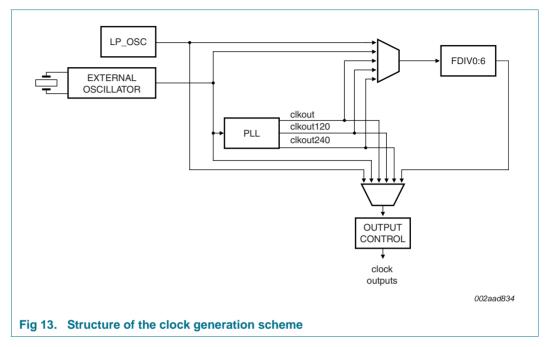
There are two primary clock generators: a low-power ring oscillator (LP_OSC) and a crystal oscillator. See Figure 12.

LP_OSC is the source for the BASE_PCR_CLK that clocks the CGU0 itself and for BASE_SAFE_CLK that clocks a minimum of other logic in the device (like the watchdog timer). To prevent the device from losing its clock source LP_OSC cannot be put into power-down. The crystal oscillator can be used as source for high-frequency clocks or as an external clock input if a crystal is not connected.

Secondary clock generators are a PLL and seven fractional dividers (FDIV0..6). The PLL has three clock outputs: normal, 120° phase-shifted and 240° phase-shifted.

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Configuration of the CGU0: For every output generator generating the base clocks a choice can be made from the primary and secondary clock generators according to Figure 13.



Any output generator (except for BASE_SAFE_CLK and BASE_PCR_CLK) can be connected to either a fractional divider (FDIV0..6) or to one of the outputs of the PLL or to LP_OSC/crystal oscillator directly. BASE_SAFE_CLK and BASE_PCR_CLK can use only LP_OSC as source.

The fractional dividers can be connected to one of the outputs of the PLL or directly to LP_OSC/crystal Oscillator.

The PLL is connected to the crystal oscillator.

In this way every output generating the base clocks can be configured to get the required clock. Multiple output generators can be connected to the same primary or secondary clock source, and multiple secondary clock sources can be connected to the same PLL output or primary clock source.

Invalid selections/programming - connecting the PLL to an FDIV or to one of the PLL outputs itself for example - will be blocked by hardware. The control register will not be written, the previous value will be kept, although all other fields will be written with new data. This prevents clocks being blocked by incorrect programming.

Default Clock Sources: Every secondary clock generator or output generator is connected to LP_OSC at reset. In this way the device runs at a low frequency after reset. It is recommended to switch BASE_SYS_CLK to a high-frequency clock generator as one of the first steps in the boot code after verifying that the high-frequency clock generator is running.

Clock Activity Detection: Clocks that are inactive are automatically regarded as invalid, and values of 'CLK_SEL' that would select those clocks are masked and not written to the control registers. This is accomplished by adding a clock detector to every clock

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generator. The RDET register keeps track of which clocks are active and inactive, and the appropriate 'CLK_SEL' values are masked and unmasked accordingly. Each clock detector can also generate interrupts at clock activation and deactivation so that the system can be notified of a change in internal clock status.

Clock detection is done using a counter running at the BASE_PCR_CLK frequency. If no positive clock edge occurs before the counter has 32 cycles of BASE_PCR_CLK the clock is assumed to be inactive. As BASE_PCR_CLK is slower than any of the clocks to be detected, normally only one BASE_PCR_CLK cycle is needed to detect activity. After reset all clocks are assumed to be 'non-present', so the RDET status register will be correct only after 32 BASE_PCR_CLK cycles.

Note that this mechanism cannot protect against a currently-selected clock going from active to inactive state. Therefore an inactive clock may still be sent to the system under special circumstances, although an interrupt can still be generated to notify the system.

Glitch-Free Switching: Provisions are included in the CGU to allow clocks to be switched glitch-free, both at the output generator stage and also at secondary source generators.

In the case of the PLL the clock will be stopped and held low for long enough to allow the PLL to stabilize and lock before being re-enabled. For all non-PLL Generators the switch will occur as quickly as possible, although there will always be a period when the clock is held low due to synchronization requirements.

If the current clock is high and does not go low within 32 *cycles of BASE_PCR_CLK* it is assumed to be inactive and is asynchronously forced low. This prevents deadlocks on the interface.

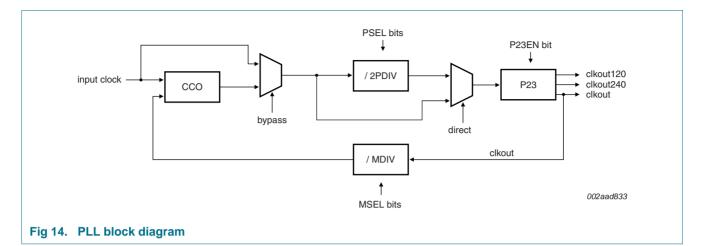
6.15.2.2 PLL functional description

A block diagram of the PLL is shown in Figure 14. The input clock is fed directly to the analog section. This block compares the phase and frequency of the inputs and generates the main clock². These clocks are either divided by $2 \times P$ by the programmable post divider to create the output clock, or sent directly to the output. The main output clock is then divided by M by the programmable feedback divider to generate the feedback clock. The output signal of the analog section is also monitored by the lock detector to signal when the PLL has locked onto the input clock.

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^{2.} Generation of the main clock is restricted by the frequency range of the PLL clock input. See Table 35, Dynamic characteristics.

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Triple output phases: For applications that require multiple clock phases two additional clock outputs can be enabled by setting register P23EN to logic 1, thus giving three clocks with a 120° phase difference. In this mode all three clocks generated by the analog section are sent to the output dividers. When the PLL has not yet achieved lock the second and third phase output dividers run unsynchronized, which means that the phase relation of the output clocks is unknown. When the PLL LOCK register is set the second and third phase of the output dividers are synchronized to the main output clock CLKOUT PLL, thus giving three clocks with a 120° phase difference.

Direct output mode: In normal operating mode (with DIRECT set to logic 0) the CCO clock is divided by 2, 4, 8 or 16 depending on the value on the PSEL[1:0] input, giving an output clock with a 50 % duty cycle. If a higher output frequency is needed the CCO clock can be sent directly to the output by setting DIRECT to logic 1. Since the CCO does not directly generate a 50 % duty cycle clock, the output clock duty cycle in this mode can deviate from 50 %.

Power-down control: A Power-down mode has been incorporated to reduce power consumption when the PLL clock is not needed. This is enabled by setting the PD control register bit. In this mode the analog section of the PLL is turned off, the oscillator and the phase-frequency detector are stopped and the dividers enter a reset state. While in Power-down mode the LOCK output is low, indicating that the PLL is not in lock. When Power-down mode is terminated by clearing the PD control-register bit the PLL resumes normal operation, and makes the LOCK signal high once it has regained lock on the input clock.

6.15.2.3 Pin description

The CGU0 module in the LPC2917/2919/01 has the pins listed in Table 27 below.

Symbol	Direction	Description		
XOUT_OSC	OUT	Oscillator crystal output		
XIN_OSC	IN	Oscillator crystal input or external clock input		

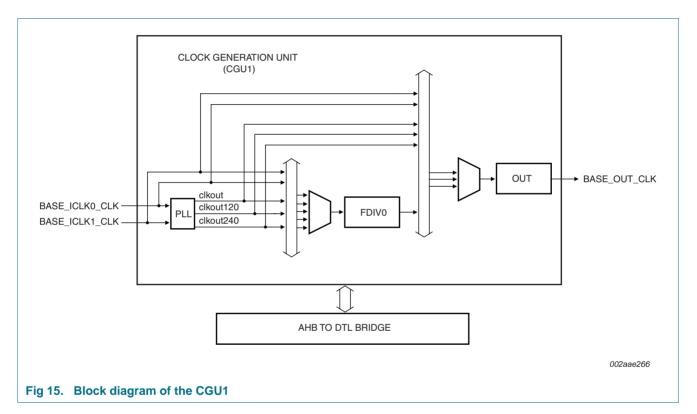
Table 27. CGU0 pins

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6.15.3 Clock generation for CLK_OUT (CGU1)

The CGU1 block is functionally identical to the CGU0 block and generates a dedicated output clock. The CGU1 block uses its own PLL and fractional divider. The PLLs used in CGU0 and CGU1 are identical (see Section 6.15.2.2).

The clock input to the CGU1 PLL is provided by one of two base clocks generated in the CGU0: BASE_ICLK0_CLK or BASE_ICLK1_CLK. The base clock not used for the PLL can be configured to drive the output clock directly.



6.15.3.1 Pin description

The CGU1 module in the LPC2917/2919/01 has the pins listed in Table 27 below.

Table 28. CGU1 pins

Symbol	Direction	Description
CLK_OUT	OUT	clock output

6.15.4 Reset Generation Unit (RGU)

The RGU controls all internal resets.

The key features of the Reset Generation Unit (RGU) are:

- Reset controlled individually per subsystem
- Automatic reset stretching and release
- Monitor function to trace resets back to source

• Register write-protection mechanism to prevent unintentional resets

6.15.4.1 Functional description

Each reset output is defined as a combination of reset input sources including the external reset input pins and internal power-on reset, see <u>Table 29</u>. The first five resets listed in this table form a sort of cascade to provide the multiple levels of impact that a reset may have. The combined input sources are logically OR-ed together so that activating any of the listed reset sources causes the output to go active.

Table 29. Reset out	put configuration	
Reset output	Reset source	Parts of the device reset when activated
POR_RST	power-on reset module	LP_OSC; is source for RGU_RST
RGU_RST	POR_RST, RST pin	RGU internal; is source for PCR_RST
PCR_RST	RGU_RST, WATCHDOG	PCR internal; is source for COLD_RST
COLD_RST	PCR_RST	parts with COLD_RST as reset source below
WARM_RST	COLD_RST	parts with WARM_RST as reset source below
SCU_RST	COLD_RST	SCU
CFID_RST	COLD_RST	CFID
FMC_RST	COLD_RST	embedded Flash-Memory Controller (FMC)
EMC_RST	COLD_RST	embedded SRAM-Memory Controller
SMC_RST	COLD_RST	external Static-Memory Controller (SMC)
GESS_A2A_RST	WARM_RST	GeSS AHB-to-APB bridge
PESS_A2A_RST	WARM_RST	PeSS AHB-to-APB bridge
GPIO_RST	WARM_RST	all GPIO modules
UART_RST	WARM_RST	all UART modules
TMR_RST	WARM_RST	all Timer modules in PeSS
SPI_RST	WARM_RST	all SPI modules
IVNSS_A2A_RST	WARM_RST	IVNSS AHB-to-APB bridge
IVNSS_CAN_RST	WARM_RST	all CAN modules including Acceptance filter
IVNSS_LIN_RST	WARM_RST	all LIN modules
MSCSS_A2A_RST	WARM_RST	MSCSS AHB to APB bridge
MSCSS_PWM_RST	WARM_RST	all PWM modules
MSCSS_ADC_RST	WARM_RST	all ADC modules
MSCSS_TMR_RST	WARM_RST	all Timer modules in MSCSS
I2C_RST	WARM_RST	all I2C modules
QEI_RST	WARM_RST	Quadrature encoder
DMA_RST	WARM_RST	GPDMA controller
VIC_RST	WARM_RST	Vectored Interrupt Controller (VIC)
AHB_RST	WARM_RST	CPU and AHB Bus infrastructure

Table 29. Reset output configuration

6.15.4.2 Pin description

The RGU module in the LPC2917/2919/01 has the following pins. <u>Table 30</u> shows the RGU pins.

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Table 30.	RGU pins	
Symbol	Direction	Description
RST	IN	external reset input, Active LOW; pulled up internally

6.15.5 Power Management Unit (PMU)

This module enables software to actively control the system's power consumption by disabling clocks not required in a particular operating mode.

Using the base clocks from the CGU as input, the PMU generates branch clocks to the rest of the LPC2917/2919/01. Output clocks branched from the same base clock are phase- and frequency-related. These branch clocks can be individually controlled by software programming.

The key features are:

- Individual clock control for all LPC2917/2919/01 sub-modules
- Activates sleeping clocks when a wake-up event is detected
- Clocks can be individually disabled by software
- · Supports AHB master-disable protocol when AUTO mode is set
- · Disables wake-up of enabled clocks when Power-down mode is set
- · Activates wake-up of enabled clocks when a wake-up event is received
- Status register is available to indicate if an input base clock can be safely switched off (i.e. all branch clocks are disabled)

6.15.5.1 Functional description

The PMU controls all internal clocks coming out of the CGU0 for power-mode management. With some exceptions, each branch clock can be switched on or off individually under control of software register bits located in its individual configuration register. Some branch clocks controlling vital parts of the device operate in a fixed mode. Table 31 shows which mode- control bits are supported by each branch clock.

By programming the configuration register the user can control which clocks are switched on or off, and which clocks are switched off when entering Power-down mode.

Note that the standby-wait-for-interrupt instructions of the ARM968E-S processor (putting the ARM CPU into a low-power state) are not supported. Instead putting the ARM CPU into power-down should be controlled by disabling the branch clock for the CPU.

Remark: For any disabled branch clocks to be re-activated their corresponding base clocks must be running (controlled by CGU0).

<u>Table 31</u> shows the relation between branch and base clocks, see also <u>Section 6.7.1</u>. Every branch clock is related to one particular base clock: it is not possible to switch the source of a branch clock in the PMU.

Table 31.Branch clock overview

Legend:

⁽¹⁾ Indicates that the related register bit is tied off to logic HIGH, all writes are ignored ⁽⁰⁾ Indicates that the related register bit is tied off to logic LOW, all writes are ignored ⁽⁺⁾ Indicates that the related register bit is readable and writable

Branch clock name	Base clock	Implemented switch on/off mechanism		
		WAKE-UP	AUTO	RUN
CLK_SAFE	BASE_SAFE_CLK	0	0	1
CLK_SYS_CPU	BASE_SYS_CLK	+	+	1
CLK_SYS	BASE_SYS_CLK	+	+	1
CLK_SYS_PCR	BASE_SYS_CLK	+	+	1
CLK_SYS_FMC	BASE_SYS_CLK	+	+	+
CLK_SYS_RAM0	BASE_SYS_CLK	+	+	+
CLK_SYS_RAM1	BASE_SYS_CLK	+	+	+
CLK_SYS_SMC	BASE_SYS_CLK	+	+	+
CLK_SYS_GESS	BASE_SYS_CLK	+	+	+
CLK_SYS_VIC	BASE_SYS_CLK	+	+	+
CLK_SYS_PESS	BASE_SYS_CLK	+	+	+
CLK_SYS_GPIO0	BASE_SYS_CLK	+	+	+
CLK_SYS_GPIO1	BASE_SYS_CLK	+	+	+
CLK_SYS_GPIO2	BASE_SYS_CLK	+	+	+
CLK_SYS_GPIO3	BASE_SYS_CLK	+	+	+
CLK_SYS_IVNSS_A	BASE_SYS_CLK	+	+	+
CLK_SYS_MSCSS_A	BASE_SYS_CLK	+	+	+
CLK_SYS_DMA	BASE_SYS_CLK	+	+	+
CLK_PCR_SLOW	BASE_PCR_CLK	+	+	1
CLK_IVNSS_APB	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_CANC0	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_CANC1	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_I2C0	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_I2C1	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_LIN0	BASE_IVNSS_CLK	+	+	+
CLK_IVNSS_LIN1	BASE_IVNSS_CLK	+	+	+
CLK_MSCSS_APB	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_MTMR0	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_MTMR1	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM0	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM1	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM2	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_PWM3	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_ADC1_APB	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_ADC2_APB	BASE_MSCSS_CLK	+	+	+
CLK_MSCSS_QEI	BASE_MSCSS_CLK	+	+	+

Table 31. Branch clock overview ...continued

Legend:

'1' Indicates that the related register bit is tied off to logic HIGH, all writes are ignored '0' Indicates that the related register bit is tied off to logic LOW, all writes are ignored '+' Indicates that the related register bit is readable and writable

Branch clock name	Base clock	Implemented switch on/off mechanism		f
		WAKE-UP	AUTO	RUN
CLK_OUT_CLK	BASE_OUT_CLK	+	+	+
CLK_UART0	BASE_UART_CLK	+	+	+
CLK_UART1	BASE_UART_CLK	+	+	+
CLK_SPI0	BASE_SPI_CLK	+	+	+
CLK_SPI1	BASE_SPI_CLK	+	+	+
CLK_SPI2	BASE_SPI_CLK	+	+	+
CLK_TMR0	BASE_TMR_CLK	+	+	+
CLK_TMR1	BASE_TMR_CLK	+	+	+
CLK_TMR2	BASE_TMR_CLK	+	+	+
CLK_TMR3	BASE_TMR_CLK	+	+	+
CLK_ADC1	BASE_ADC_CLK	+	+	+
CLK_ADC2	BASE_ADC_CLK	+	+	+

6.16 Vectored Interrupt Controller (VIC)

The LPC2917/2919/01 contains a very flexible and powerful Vectored Interrupt Controller to interrupt the ARM processor on request.

The key features are:

- Level-active interrupt request with programmable polarity.
- 56 interrupt-request inputs.
- Software-interrupt request capability associated with each request input.
- Interrupt request state can be observed before masking.
- Software-programmable priority assignments to interrupt requests up to 15 levels.
- Software-programmable routing of interrupt requests towards the ARM-processor inputs IRQ and FIQ.
- Fast identification of interrupt requests through vector.
- Support for nesting of interrupt service routines.

6.16.1 Functional description

The Vectored Interrupt Controller routes incoming interrupt requests to the ARM processor. The interrupt target is configured for each interrupt request input of the VIC. The targets are defined as follows:

- Target 0 is ARM processor FIQ (fast interrupt service).
- Target 1 is ARM processor IRQ (standard interrupt service).

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Interrupt-request masking is performed individually per interrupt target by comparing the priority level assigned to a specific interrupt request with a target-specific priority threshold. The priority levels are defined as follows:

- Priority level 0 corresponds to 'masked' (i.e. interrupt requests with priority 0 never lead to an interrupt).
- Priority 1 corresponds to the lowest priority.
- Priority 15 corresponds to the highest priority.

Software interrupt support is provided and can be supplied for:

- Testing RTOS (Real-Time Operating System) interrupt handling without using device-specific interrupt service routines.
- Software emulation of an interrupt-requesting device, including interrupts.

6.16.2 Clock description

The VIC is clocked by CLK_SYS_VIC, see Section 6.7.2.

7. Limiting values

Table 32. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Supply pins						
P _{tot}	total power dissipation		<u>[1]</u>	-	1.5	W
V _{DD(CORE)}	core supply voltage			-0.5	+2.0	V
V _{DD(OSC_PLL)}	oscillator and PLL supply voltage			-0.5	+2.0	V
V _{DDA(ADC3V3)}	3.3 V ADC analog supply voltage			-0.5	+4.6	V
V _{DD(IO)}	input/output supply voltage			-0.5	+4.6	V
I _{DD}	supply current	average value per supply pin	[2]	-	98	mA
I _{SS}	ground current	average value per ground pin	[2]	-	98	mA
Input pins and	d I/O pins					
V _{XIN_OSC}	voltage on pin XIN_OSC			-0.5	+2.0	V
V _{I(IO)}	I/O input voltage		[3][4][5]	-0.5	$V_{DD(IO)}$ + 3.0	V
V _{I(ADC)}	ADC input voltage	for ADC1/2: I/O port 0 pin 8 to pin 23.	<u>[4][5]</u>	-0.5	V _{DDA(ADC3V3)} + 0.5	V
V _{VREFP}	voltage on pin VREFP			-0.5	+3.6	V
V _{VREFN}	voltage on pin VREFN			-0.5	+3.6	V
I _{I(ADC)}	ADC input current	average value per input pin	[2]	-	35	mA
Output pins a	nd I/O pins configured as ou	ıtput				
I _{OHS}	HIGH-level short-circuit output current	drive HIGH, output shorted to $V_{SS(IO)}$	<u>[6]</u>	-	-33	mA
I _{OLS}	LOW-level short-circuit output current	drive LOW, output shorted to $V_{DD(IO)}$	<u>[6]</u>	-	+38	mA
General						
T _{stg}	storage temperature			-65	+150	°C
T _{amb}	ambient temperature			-40	+85	°C

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Table 32. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
ESD					
V _{ESD}	electrostatic discharge voltage	on all pins			
		human body model	<u>[7]</u> –2000	+2000	V
		charged device model	-500	+500	V
		on corner pins			
		charged device model	-750	+750	V

[1] Based on package heat transfer, not device power consumption.

[2] Peak current must be limited at 25 times average current.

[3] For I/O Port 0, the maximum input voltage is defined by $V_{I(\mbox{ADC})}.$

[4] Only when V_{DD(IO)} is present.

[5] Note that pull-up should be off. With pull-up do not exceed 3.6 V.

[6] 112 mA per $V_{DD(IO)}$ or $V_{SS(IO)}$ should not be exceeded.

[7] Human-body model: discharging a 100 pF capacitor via a 10 k Ω series resistor.

8. Static characteristics

Table 33. Static characteristics

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DDA(ADC3V3)} = 3.0$ V to 3.6 V; $T_{vj} = -40$ °C to +85 °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Supplies							
Core supply							
V _{DD(CORE)}	core supply voltage			1.71	1.80	1.89	V
I _{DD(CORE)}	core supply current	<pre>Device state after reset; system clock at 125 MHz; T_{amb} = 85 °C; executing code while(1){} from flash.</pre>		-	75	-	mA
		all clocks off	[2]	-	30	475	μA
I/O supply							
V _{DD(IO)}	input/output supply voltage			2.7	-	3.6	V
I _{DD(IO)}	I/O supply current	Power-down mode		-	0.5	3.25	μΑ
Oscillator sup	ply						
V _{DD(OSC_PLL)}	oscillator and PLL supply voltage			1.71	1.80	1.89	V
I _{DD(OSC_PLL)}	oscillator and PLL supply	normal mode		-	-	1	mA
	current	Power-down mode		-	-	2	μΑ
Analog-to-dig	ital converter supply						
V _{DDA(ADC3V3)}	3.3 V ADC analog supply voltage			3.0	3.3	3.6	V
I _{DDA(ADC3V3)}	3.3 V ADC analog supply	normal mode		-	-	1.9	mA
	current	Power-down mode		-	-	4	μΑ
Input pins an	nd I/O pins configured as i	nput					
VI	input voltage	all port pins and $V_{DD(IO)}$ applied;	<u>[3][4]</u>	-0.5	-	+ 5.5	V
		see Section 7					
		port 0 pins 8 to 23 when ADC1/2 is used	[4]			V _{VREFP}	
		all port pins and $V_{DD(IO)}$ not applied		-0.5	-	+3.6	V
		all other I/O pins, RST, TRST, TDI, JTAGSEL, TMS, TCK		-0.5	-	V _{DD(IO)}	V
V _{IH}	HIGH-level input voltage	all port pins, RST, TRST, TDI, JTAGSEL, TMS, TCK; see <u>Figure 22</u>		2.0	-	-	V
VIL	LOW-level input voltage	all port pins, RST, TRST, TDI, JTAGSEL, TMS, TCK; see <u>Figure 21</u>		-	-	0.8	V
V _{hys}	hysteresis voltage			0.4	-	-	V

Table 33. Static characteristics ...continued

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DDA(ADC3V3)} = 3.0$ V to 3.6 V; $T_{vj} = -40$ °C to +85 °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{LIH}	HIGH-level input leakage current			-	-	1	μΑ
I _{LIL}	LOW-level input leakage current			-	-	1	μA
I _{I(pd)}	pull-down input current	all port pins, $V_I = 3.3 V$; $V_I = 5.5 V$; see <u>Figure 23</u>		25	50	100	μA
I _{I(pu)}	pull-up input current	all port pins, \overline{RST} , \overline{TRST} , TDI, JTAGSEL, TMS: V _I = 0 V; V _I > 3.6 V is not allowed; see <u>Figure 24</u>		-25	-50	–115	μA
Ci	input capacitance		[5]	-	3	8	pF
Output pins	and I/O pins configured as	output					
Vo	output voltage			0	-	V _{DD(IO)}	V
V _{OH}	HIGH-level output voltage	$I_{OH} = -4 \text{ mA}$		$V_{DD(IO)} - 0.4$	-	-	V
V _{OL}	LOW-level output voltage	$I_{OL} = 4 \text{ mA}$		-	-	0.4	V
CL	load capacitance			-	-	25	pF
Oscillator							
V _{XIN_OSC}	voltage on pin XIN_OSC			0	-	1.8	V
R _{s(xtal)}	crystal series resistance	f_{osc} = 10 MHz to 15 MHz	[6]				
		$C_{xtal} = 10 \text{ pF};$ $C_{ext} = 18 \text{ pF}$		-	-	160	Ω
		$C_{xtal} = 20 \text{ pF};$ $C_{ext} = 39 \text{ pF}$		-	-	60	Ω
		$f_{osc} = 15 \text{ MHz} \text{ to } 20 \text{ MHz}$	[6]				
		$C_{xtal} = 10 \text{ pF};$ $C_{ext} = 18 \text{ pF}$		-	-	80	Ω
Ci	input capacitance	of XIN_OSC	[7]	-		2	pF
Power-up re	eset						
V _{trip(high)}	high trip level voltage		<u>[8]</u>	1.1	1.4	1.6	V
V _{trip(low)}	low trip level voltage		<u>[8]</u>	1.0	1.3	1.5	V
V _{trip(dif)}	difference between high and low trip level voltage		<u>[8]</u>	50	120	180	mV

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at T_{amb} = 85 °C on wafer level. Cased products are tested at T_{amb} = 25 °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power-supply voltage range.

[2] Leakage current is exponential to temperature; worst-case value is at 85 °C T_{vj}. All clocks off. Analog modules and FLASH powered down.

[3] Not 5 V-tolerant when pull-up is on.

[4] For I/O Port 0, the maximum input voltage is defined by $V_{I(ADC)}$.

- [5] For Port 0, pin 0 to pin 15 add maximum 1.5 pF for input capacitance to ADC. For Port 0, pin 16 to pin 31 add maximum 1.0 pF for input capacitance to ADC.
- [6] C_{xtal} is crystal load capacitance and C_{ext} are the two external load capacitors.
- [7] This parameter is not part of production testing or final testing, hence only a typical value is stated. Maximum and minimum values are based on simulation results.

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[8] The power-up reset has a time filter: V_{DD(CORE)} must be above V_{trip(high)} for 2 μs before reset is de-asserted; V_{DD(CORE)} must be below V_{trip(low)} for 11 μs before internal reset is asserted.

Table 34. ADC static characteristics

V_{DDA(ADC3V3)} = 3.0 V to 3.6 V; T_{amb} = -40 °C to +85 °C unless otherwise specified; ADC frequency 4.5 MHz.

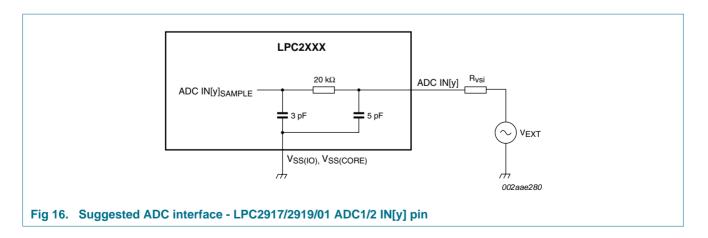
(
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{VREFN}	voltage on pin VREFN			0	-	$V_{\text{VREFP}}-2$	V
V _{VREFP}	voltage on pin VREFP			V_{VREFN} + 2	-	V _{DDA(ADC3V3)}	V
Z _i	input impedance	between V_{VREFN} and V_{VREFP}		4.4	-	-	kΩ
V _{IA}	analog input voltage			V_{VREFN}	-	V _{VREFP}	V
C _{ia}	analog input capacitance			-	-	1	pF
E _D	differential linearity error		<u>[1][2][3]</u>		-	±1	LSB
E _{L(adj)}	integral non-linearity		<u>[1][4]</u>	-	-	±2	LSB
E _O	offset error		<u>[1][5]</u>	-	-	±3	LSB
E _G	gain error		<u>[1][6]</u>	-	-	±0.5	%
E _T	absolute error		<u>[1][7]</u>	-	-	±4	LSB
R _{vsi}	voltage source interface resistance		[8]	-	-	40	kΩ

[1] Conditions: $V_{SS(IO)} = 0 V$, $V_{DDA(ADC3V3)} = 3.3 V$.

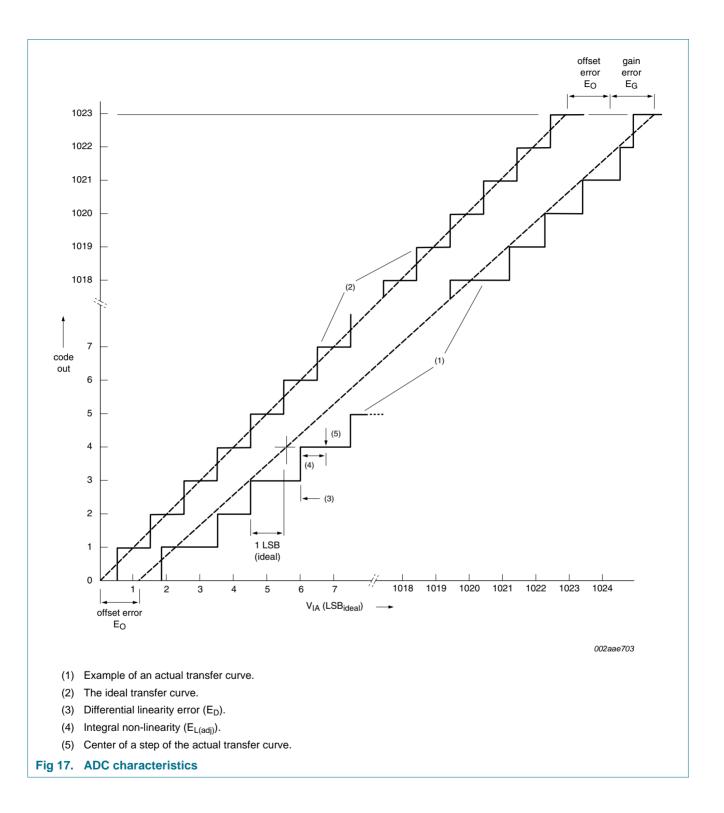
[2] The ADC is monotonic, there are no missing codes.

[3] The differential linearity error (E_D) is the difference between the actual step width and the ideal step width. See Figure 17.

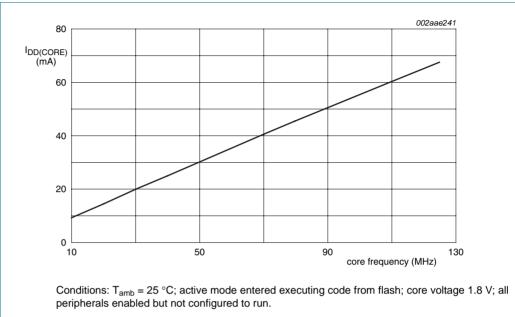
- [4] The integral non-linearity (E_{L(adj)}) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See Figure 17.
- [5] The offset error (E_O) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See Figure 17.
- [6] The gain error (E_G) is the relative difference in percent between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See Figure 17.
- [7] The absolute error (E_T) is the maximum difference between the center of the steps of the actual transfer curve of the non-calibrated ADC and the ideal transfer curve. See Figure 17.
- [8] See Figure 16.



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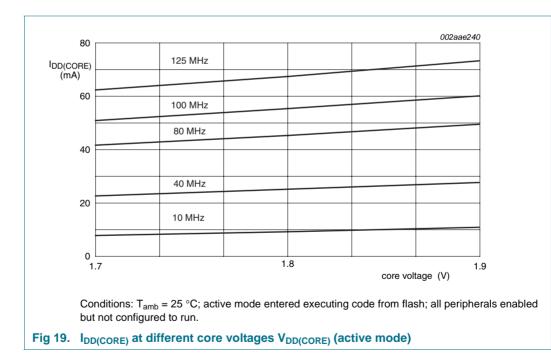


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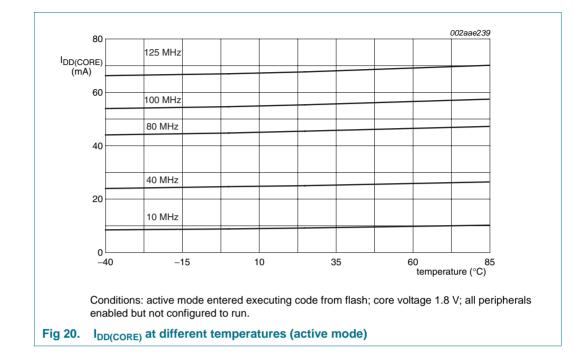


8.1 Power consumption

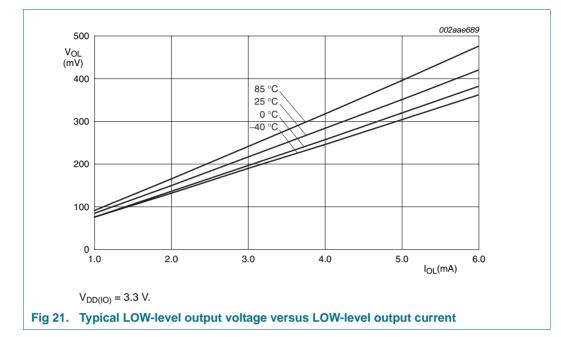




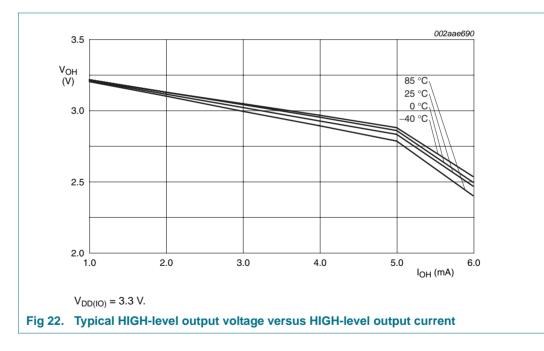
ARM9 microcontroller with CAN and LIN



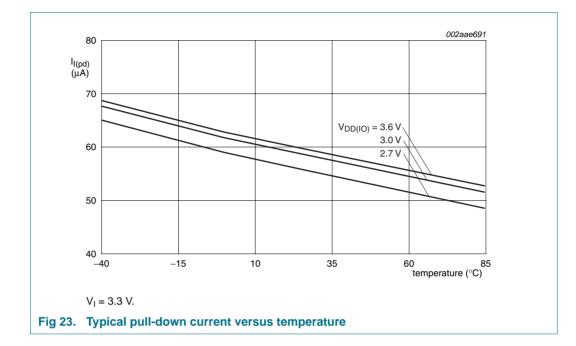
ARM9 microcontroller with CAN and LIN

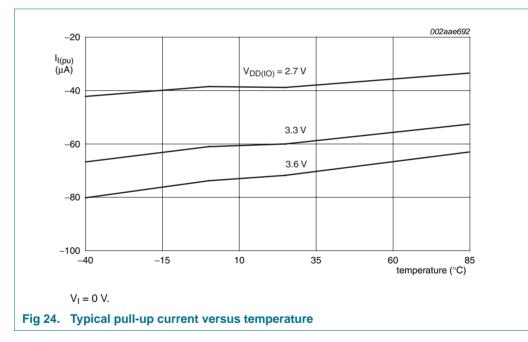


8.2 Electrical pin characteristics



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9. Dynamic characteristics

9.1 Dynamic characteristics: I/O pins, internal clock, oscillators, PLL, and CAN

Table 35. Dynamic characteristics

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7 \text{ V to } 3.6 \text{ V}$; $V_{DDA(ADC3V3)} = 3.0 \text{ V to } 3.6 \text{ V}$; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I/O pins							
t _{THL}	HIGH to LOW transition time	C _L = 30 pF		4	-	13.8	ns
t _{TLH}	LOW to HIGH transition time	C _L = 30 pF		4	-	13.8	ns
CLKOUT pin							
f _{clk}	clock frequency	on pin CLKOUT		-	-	40	MHz
Internal clock							
f _{clk(sys)}	system clock frequency		[2]	10	-	125	MHz
T _{clk(sys)}	system clock period		[2]	8	-	100	ns
Low-power ring	oscillator						
f _{ref(RO)}	RO reference frequency			0.36	0.4	0.42	MHz
t _{startup}	start-up time	at maximum frequency	[3]	-	6	-	μs
Oscillator							
f _{i(osc)}	oscillator input frequency	maximum frequency is the clock input of an external clock source applied to the XIN_OSC pin		10	-	100	MHz
t _{startup}	start-up time	at maximum frequency	<u>[3]</u> [4]	-	500	-	μS
PLL							
f _{i(PLL)}	PLL input frequency			10	-	25	MHz
f _{o(PLL)}	PLL output frequency			10	-	160	MHz
		CCO; direct mode		156	-	320	MHz
t _{a(clk)}	clock access time			-	-	63.4	ns
t _{a(A)}	address access time			-	-	60.3	ns

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Table 35. Dynamic characteristics ... continued

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DDA(ADC3V3)} = 3.0$ V to 3.6 V; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

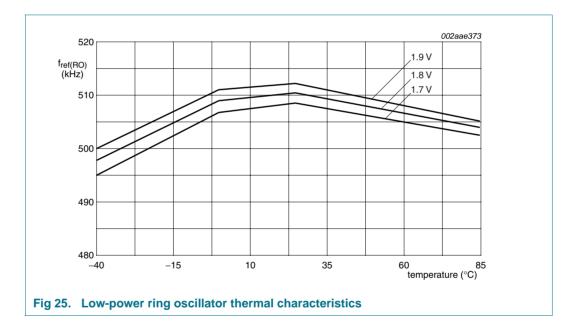
Jitter specification for CAN t _{jit(cc)(p-p)} cycle to cycle jitter (peak-to-peak value) on CAN TXDC pin 3 - 0.4 1 ns	Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
	Jitter specification for CAN							
	t _{jit(cc)(p-p)}	, , ,	on CAN TXDC pin	<u>[3]</u> _	0.4	1	ns	

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at $T_{amb} = 85$ °C ambient temperature on wafer level. Cased products are tested at $T_{amb} = 25$ °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.

[2] See <u>Table 26</u>.

[3] This parameter is not part of production testing or final testing, hence only a typical value is stated.

[4] Oscillator start-up time depends on the quality of the crystal. For most crystals it takes about 1000 clock pulses until the clock is fully stable.



9.2 Dynamic characteristics: I²C-bus interface

Table 36. Dynamic characteristic: I²C-bus pins

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DDA(ADC3V3)} = 3.0$ V to 3.6 V; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified^[1]

Symbol	Parameter	Conditions	Min	Typ <mark>[2]</mark>	Max	Unit
t _{f(0)}	output fall time	V_{IH} to V_{IL}	$20 + 0.1 \times C_b^{[3]}$	-	-	ns

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at T_{amb} = 85 °C ambient temperature on wafer level. Cased products are tested at T_{amb} = 25 °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.

[2] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

[3] Bus capacitance C_b in pF, from 10 pF to 400 pF.

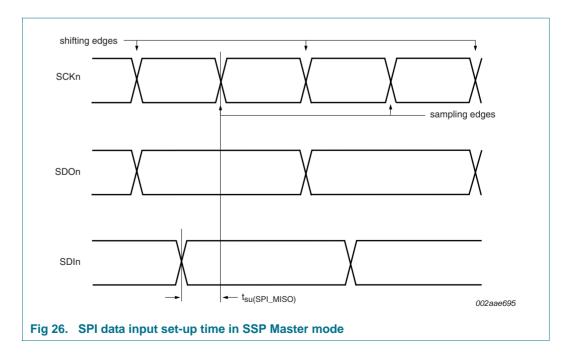
9.3 Dynamic characteristics: SPI

Table 37. Dynamic characteristics of SPI pins

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7$ V to 3.6 V; $V_{DDA(ADC3V3)} = 3.0$ V to 3.6 V; $V_{DDA(ADC5V0)} = 3.0$ V to 5.5 V; $T_{vj} = -40$ °C to +85 °C; all voltages are measured with respect to ground; positive currents flow into the IC; unless otherwise specified.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{SPI}	SPI operating frequency	master operation	¹ / ₆₅₀₂₄ f _{clk(SPI)}	-	$^{1/2}f_{clk(SPI)}$	MHz
		slave operation	$1_{65024} f_{clk(SPI)}$	-	¹∕₄f _{clk(SPI)}	MHz
t _{su(SPI_MISO)}	SPI_MISO set-up time	T _{amb} = 25 °C; measured in SPI Master mode; see <u>Figure 26</u>	-	11	-	ns

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at $T_{amb} = 85 \text{ °C}$ ambient temperature on wafer level. Cased products are tested at $T_{amb} = 25 \text{ °C}$ (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.



9.4 Dynamic characteristics: flash memory and EEPROM

Table 38. Flash characteristics

 $T_{amb} = -40 \degree C$ to $+85 \degree C$; $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7 V$ to 3.6 V; $V_{DDA(ADC3V3)} = 3.0 V$ to 3.6 V; all voltages are measured with respect to ground.

(-/	-		-	-		
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
N _{endu}	endurance		[1]	10000	-	-	cycles
t _{ret}	retention time	powered		10	-	-	years
		unpowered		20	-	-	years
t _{prog}	programming time	word		0.95	1	1.05	ms
t _{er}	erase time	global		95	100	105	ms
		sector		95	100	105	ms
t _{init}	initialization time			-	-	150	μs
t _{wr(pg)}	page write time			0.95	1	1.05	ms
t _{fl(BIST)}	flash word BIST time			-	38	70	ns
t _{a(clk)}	clock access time			-	-	63.4	ns
t _{a(A)}	address access time			-	-	60.3	ns

[1] Number of program/erase cycles.

Table 39. EEPROM characteristics

 $\begin{array}{l} T_{amb} = -40 ~^{\circ}C ~to ~+85 ~^{\circ}C; ~V_{DD(CORE)} = V_{DD(OSC_PLL)}; ~V_{DD(IO)} = 2.7 ~V ~to ~3.6 ~V; \\ V_{DDA(ADC3V3)} = 3.0 ~V ~to ~3.6 ~V; ~all ~voltages ~are ~measured with respect to ground. \end{array}$

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{clk}	clock frequency		200	375	400	kHz
N _{endu}	endurance		100000	500000	-	cycles
t _{ret}	retention time	powered	10	-	-	years

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9.5 Dynamic characteristics: external static memory

Table 40. External static memory interface dynamic characteristics

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7 \text{ V to } 3.6 \text{ V}$; $V_{DDA(ADC3V3)} = 3.0 \text{ V to } 3.6 \text{ V}$; all voltages are measured with respect to ground.^[1]

ground.						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T _{CLCL}	clock cycle time		8	-	100	ns
t _{a(R)int}	internal read access time		-	-	20.5	ns
t _{a(W)int}	internal write access time		-	-	24.9	ns
Read cyc	le parameters					
t _{CSLAV}	CS LOW to address valid time		-5	-2.5	-	ns
t _{OELAV}	OE LOW to address valid time		$-5 - WSTOEN \times T_{CLCL}$	$-2.5 - WSTOEN \times T_{CLCL}$	-	ns
t _{CSLOEL}	CS LOW to OE LOW time		-	0 + WSTOEN \times T _{CLCL}	-	ns
t _{su(DQ)}	data input /output set-up time		11	16	22	ns
t _{h(D)}	data input hold time		0	2.5	5	ns
t _{CSHOEH}	CS HIGH to OE HIGH time		-	0	-	ns
t _{BLSLBLSH}	BLS LOW to BLS HIGH time		-	(WST1 – WSTOEN +1) × T_{CLCL}	-	ns
t _{OELOEH}	\overline{OE} LOW to \overline{OE} HIGH time		-	(WST1 – WSTOEN +1) × T_{CLCL}	-	ns
t _{BLSLAV}	BLS LOW to address valid time		-	0 + WSTOEN $\times T_{CLCL}$	-	ns
Write cyc	le parameters					
t _{CSHBLSH}	$\overline{\text{CS}}$ HIGH to $\overline{\text{BLS}}$ HIGH time	[2]	-	0	-	ns
t _{CSLWEL}	$\overline{\text{CS}}$ LOW to $\overline{\text{WE}}$ LOW time		-	(WSTWEN + 0.5) \times T _{CLCL}	-	ns
t _{CSLBLSL}	CS LOW to BLS LOW time	<u>[3]</u>	-	$WSTWEN \times T_{CLCL}$	-	ns
t _{WELDV}	WE LOW to data valid time		-	(WSTWEN + 0.5) \times T _{CLCL}	-	ns
t _{CSLDV}	$\overline{\text{CS}}$ LOW to data valid time		-0.5	-0.1	0.3	ns
t _{WELWEH}	\overline{WE} LOW to \overline{WE} HIGH time		-	(WST2 – WSTWEN +1) × T_{CLCL}	-	ns
t _{BLSLBLSH}	BLS LOW to BLS HIGH time	<u>[4]</u>	-	(WST2 - WSTWEN +2) × T_{CLCL}	-	ns

[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at $T_{amb} = 85$ °C ambient temperature on wafer level. Cased products are tested at $T_{amb} = 25$ °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.

[2] When the byte lane select signals are used to connect the write enable input (8 bit devices), $t_{CSHBLSH} = -0.5 \times T_{CLCL}$.

[3] When the byte lane select signals are used to connect the write enable input (8 bit devices), t_{CSLBLSL} = t_{CSLWEL}.

[4] For 16 and 32 bit devices.

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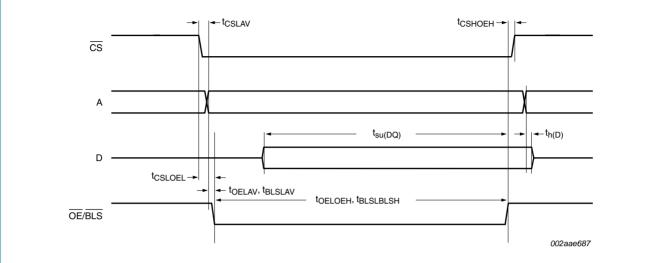
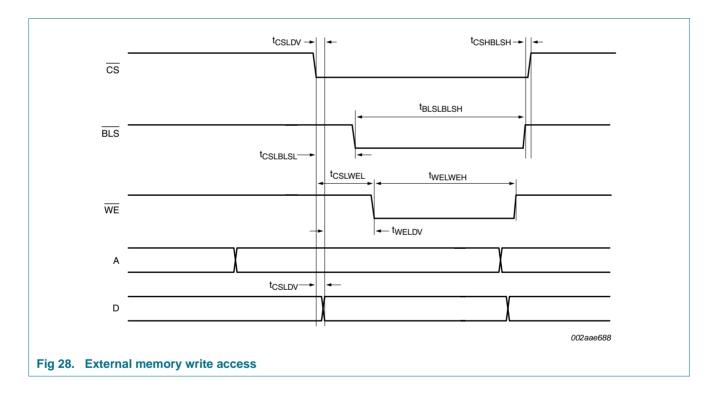


Fig 27. External memory read access



9.6 Dynamic characteristics: ADC

Table 41. ADC dynamic characteristics

 $V_{DD(CORE)} = V_{DD(OSC_PLL)}$; $V_{DD(IO)} = 2.7 V$ to 3.6 V; $V_{DDA(ADC3V3)} = 3.0 V$ to 3.6 V; all voltages are measured with respect to ground.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{i(ADC)}	ADC input frequency		[2] 4	-	4.5	MHz
f _{s(max)}	maximum sampling rate	$\begin{array}{l} f_{i(ADC)} = 4.5 \mbox{ MHz}; \\ f_s = f_{i(ADC)}/(n+1) \mbox{ with} \\ n = resolution \end{array}$				
		resolution 2 bit	-	-	1500	ksample/s
		resolution 10 bit	-	-	400	ksample/s
t _{conv}	conversion time	In number of ADC clock cycles	3	-	11	cycles
		In number of bits	2	-	10	bits

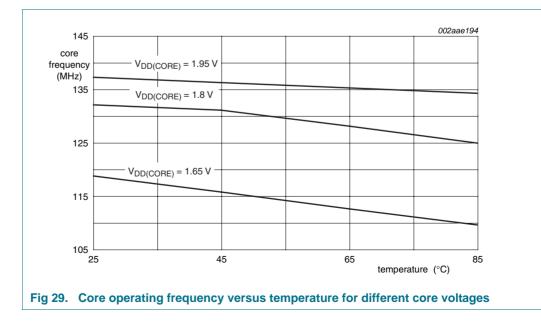
[1] All parameters are guaranteed over the virtual junction temperature range by design. Pre-testing is performed at $T_{amb} = 85$ °C ambient temperature on wafer level. Cased products are tested at $T_{amb} = 25$ °C (final testing). Both pre-testing and final testing use correlated test conditions to cover the specified temperature and power supply voltage range.

[2] Duty cycle clock should be as close as possible to 50 %.

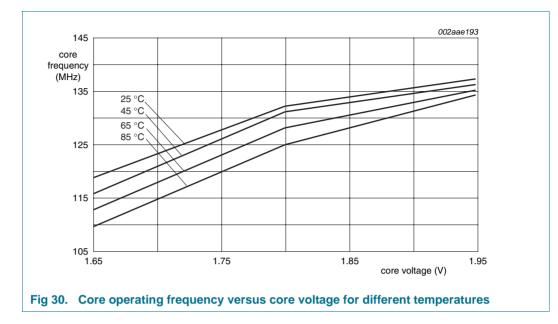
10. Application information

10.1 Operating frequency selection

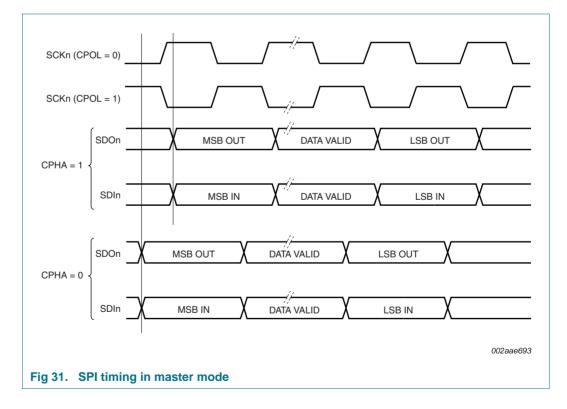
The LPC2917/2919/01 is specified to operate at a maximum frequency of 125 MHz, maximum temperature of 85 °C, and maximum core voltage of 1.89 V. Figure 29 and Figure 30 show that the user can achieve higher operating frequencies for the LPC2917/2919/01 by controlling the temperature and the core voltage accordingly.



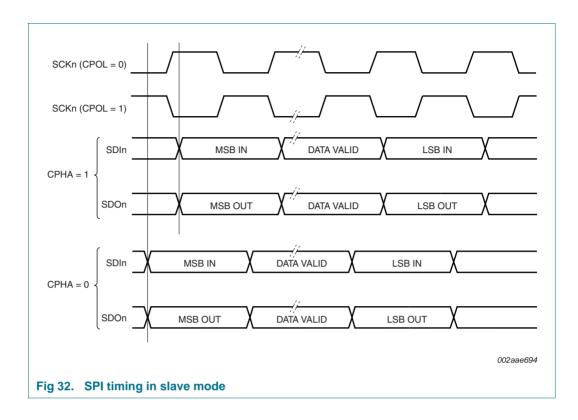
ARM9 microcontroller with CAN and LIN



10.2 SPI signal forms

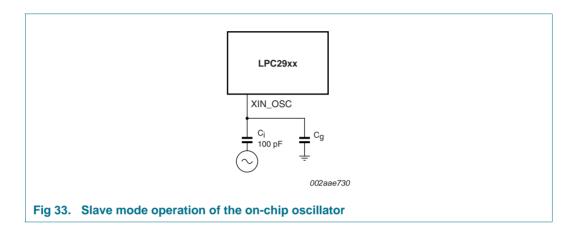


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10.3 XIN_OSC input

The input voltage to the on-chip oscillators is limited to 1.8 V. If the oscillator is driven by a clock in slave mode, it is recommended that the input be coupled through a capacitor with $C_i = 100 \text{ pF}$. To limit the input voltage to the specified range, choose an additional capacitor to ground C_g which attenuates the input voltage by a factor $C_i/(C_i + C_g)$. In slave mode, a minimum of 200 mV_{rms} is needed. For more details see the *LPC29xx User manual UM10316*.



10.4 XIN_OSC Printed Circuit Board (PCB) layout guidelines

The crystal should be connected on the PCB as close as possible to the oscillator input and output pins of the chip. Take care that the load capacitors C_{x1} and C_{x2} , and C_{x3} in case of third overtone crystal usage, have a common ground plane. The external components must also be connected to the ground plain. Loops must be made as small as possible, in order to keep the noise coupled in via the PCB as small as possible. Also parasitics should stay as small as possible. Values of C_{x1} and C_{x2} should be chosen smaller accordingly to the increase in parasitics of the PCB layout.

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11. Package outline

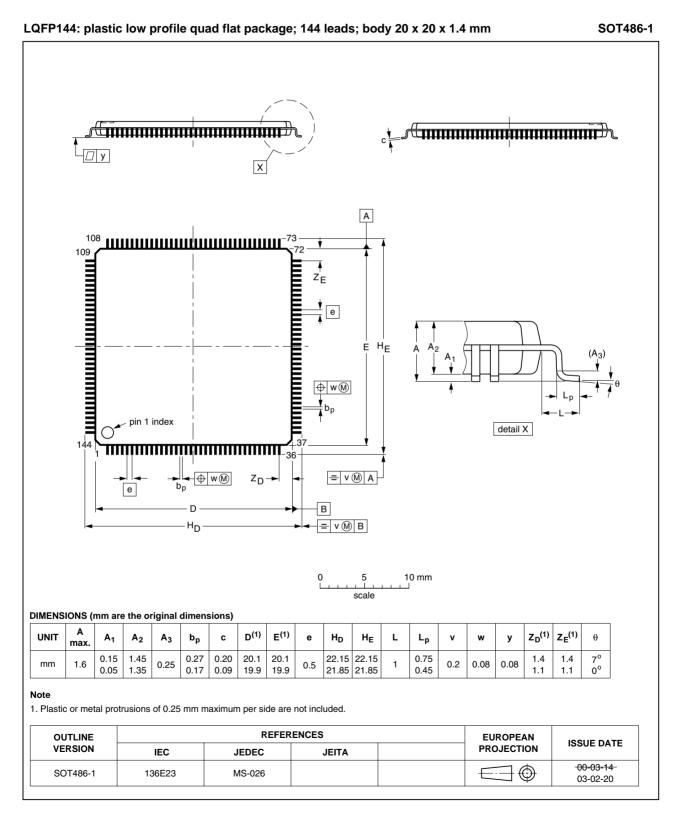


Fig 34. Package outline SOT486-1 (LQFP144)

LPC2917_19_01_3

12. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow* soldering description".

12.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

12.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- · Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

12.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

12.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 35</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 42 and 43

Table 42.	SnPb eutectic p	process (from	J-STD-020C)
-----------	-----------------	---------------	-------------

Package thickness (mm)	Package reflow temperature (°C)		
	Volume (mm ³)		
	< 350	≥ 350	
< 2.5	235	220	
≥ 2.5	220	220	

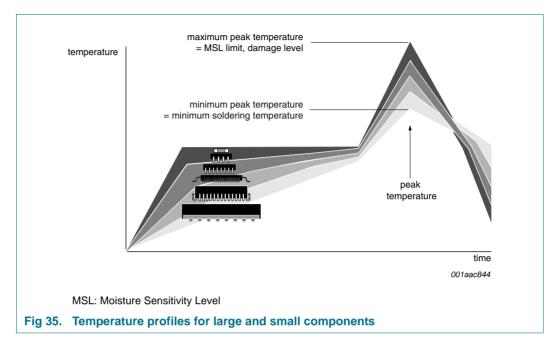
Table 43. Lead-free process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C) Volume (mm ³)			
	< 350	350 to 2000	> 2000	
< 1.6	260	260	260	
1.6 to 2.5	260	250	245	
> 2.5	250	245	245	

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 35.

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For further information on temperature profiles, refer to Application Note *AN10365 "Surface mount reflow soldering description"*.

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13. Abbreviations

Abbreviation	Description
AHB	Advanced High-performance Bus
AMBA	Advanced Microcontroller Bus Architecture
APB	ARM Peripheral Bus
BCL	Buffer Control List
BDL	Buffer Descriptor List
BEL	Buffer Entry List
BIST	Built-In Self Test
CCO	Current Controlled Oscillator
CISC	Complex Instruction Set Computers
DMA	Direct Memory Access
DSP	Digital Signal Processing
DTL	Device Transaction Level
ЕТВ	Embedded Trace Buffer
ETM	Embedded Trace Macrocell
FIQ	Fast Interrupt reQuest
GPDMA	General Purpose DMA
RQ	Interrupt Request
LIN	Local Interconnect Network
MAC	Media Access Control
PLL	Phase-Locked Loop
RISC	Reduced Instruction Set Computer
SFSP	SCU Function Select Port x,y (use without the P if there are no x,y)
SCL	Slot Control List
UART	Universal Asynchronous Receiver Transmitter

14. References

- [1] UM10316 LPC29xx user manual
- [2] ARM ARM web site
- [3] ARM-SSP ARM primecell synchronous serial port (PL022) technical reference manual
- [4] CAN ISO 11898-1: 2002 road vehicles Controller Area Network (CAN) part 1: data link layer and physical signalling
- [5] LIN LIN specification package, revision 2.0

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15. Revision history

Table 45. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes	
LPC2917_19_01_3	20091209	Product data sheet	-	LPC2917_19_01_2	
LPC2917_19_01_2	20090617	Preliminary data sheet	-	LPC2917_19_01_1	
LPC2917_19_01_1	20090112	Preliminary data sheet	-	-	

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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